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MACHINE-LEARNING ERROR MODELS FOR APPROXIMATE SOLUTIONS TO PARAMETERIZED SYSTEMS OF NONLINEAR EQUATIONS

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Outline

- Introduction
- Parameterized Systems of Nonlinear Equations
- Proposed Approach
- Numerical Experiments
- Summary

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- Introduction
 - Motivation
 - Solution Approximations
 - Uncertainty Quantification
- Parameterized Systems of Nonlinear Equations
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Motivation

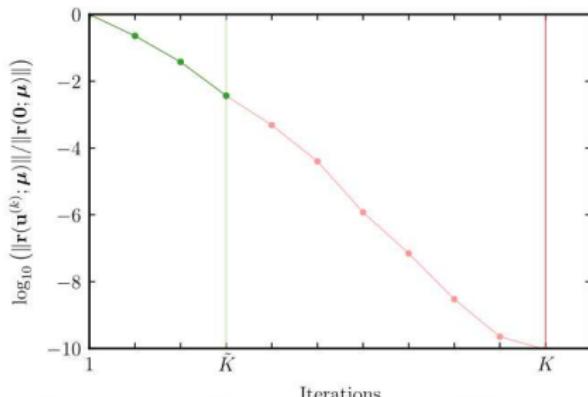
- Many-query problems can impose a formidable computational burden
- **Solution approximations** can exchange fidelity for speed

Solution Approximations

- **Inexact solutions:** When solving nonlinear equations, prematurely end the iterative process
- **Lower-fidelity models:** Neglect physical phenomena, coarsen the mesh, or use lower-order finite differences or elements
- **Reduced-order models:** Approximate solution with a linear combination of $m_u \ll N_u$ basis functions

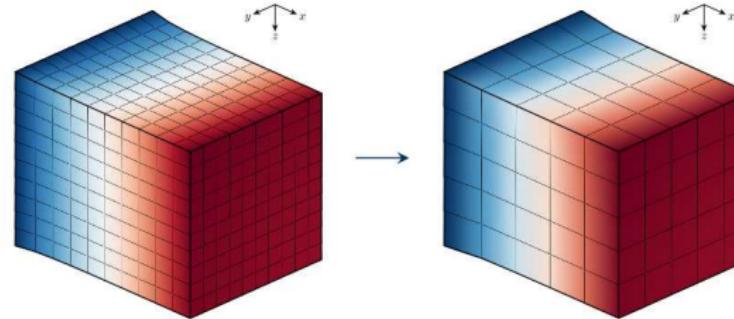
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Solution Approximations

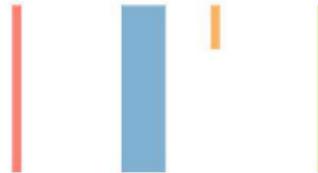
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$$\tilde{\mathbf{u}}(\boldsymbol{\mu}) = \Phi_{\mathbf{u}} \hat{\mathbf{u}}(\boldsymbol{\mu}) + \bar{\mathbf{u}}$$



Uncertainty Quantification

- Solution approximations require **less time** than high-fidelity models but **introduce an error** (i.e., epistemic uncertainty)
- Ultimate task should account for **all sources of uncertainty**
- We quantify the uncertainty by
 - 1) **engineering features** informative of the error
 - **cheaply computable**
 - **generated by approximate model**
 - 2) applying **machine learning regression** techniques to construct a mapping from these features to a distribution of the error
- This work matures our previously developed capabilities:
 - Hand-selecting one feature and applying Gaussian process regression
M. Drohmann and K. Carlberg (2015)
 - Modeling dynamical systems error using machine learning methods
S. Trehan et al. (2017)

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Parameterized Systems of Nonlinear Equations

Parameterized systems of nonlinear equations

$$\mathbf{r}(\mathbf{u}(\boldsymbol{\mu}); \boldsymbol{\mu}) = \mathbf{0}$$

- $\mathbf{r} : \mathbb{R}^{N_{\mathbf{u}}} \times \mathbb{R}^{N_{\boldsymbol{\mu}}} \rightarrow \mathbb{R}^{N_{\mathbf{u}}}$ residual, nonlinear in at least $\mathbf{u}(\boldsymbol{\mu})$
- $\mathbf{u} : \mathbb{R}^{N_{\boldsymbol{\mu}}} \rightarrow \mathbb{R}^{N_{\mathbf{u}}}$ state (solution vector)
- $\boldsymbol{\mu} \in \mathcal{D}$ parameters in parameter domain $\mathcal{D} \subseteq \mathbb{R}^{N_{\boldsymbol{\mu}}}$

Quantity of Interest

Scalar-valued quantity of interest

$$s(\boldsymbol{\mu}) := g(\mathbf{u}(\boldsymbol{\mu}))$$

- $s : \mathbb{R}^{N_{\boldsymbol{\mu}}} \rightarrow \mathbb{R}$ quantity of interest
- $g : \mathbb{R}^{N_{\mathbf{u}}} \rightarrow \mathbb{R}$ quantity of interest functional

Approximate Solutions

- Computing the exact solution $\mathbf{u}(\boldsymbol{\mu})$ can be
 - prohibitively expensive (large $N_{\mathbf{u}}$)
 - unnecessary (inexact solutions suffice for optimization convergence)
- Such cases require an approximate solution $\tilde{\mathbf{u}} : \mathbb{R}^{N_{\boldsymbol{\mu}}} \rightarrow \mathbb{R}^{N_{\mathbf{u}}}$
- Approximate solution leads to approximated quantity of interest

$$\tilde{s}(\mu) := g(\tilde{\mathbf{u}}(\mu)),$$

where $\tilde{s} : \mathbb{R}^{N_\mu} \rightarrow \mathbb{R}$

Approximate Solutions (continued)

We consider 3 approaches for computing approximate solutions:

- 1) Inexact solutions
- 2) Lower-fidelity models
- 3) Model reduction

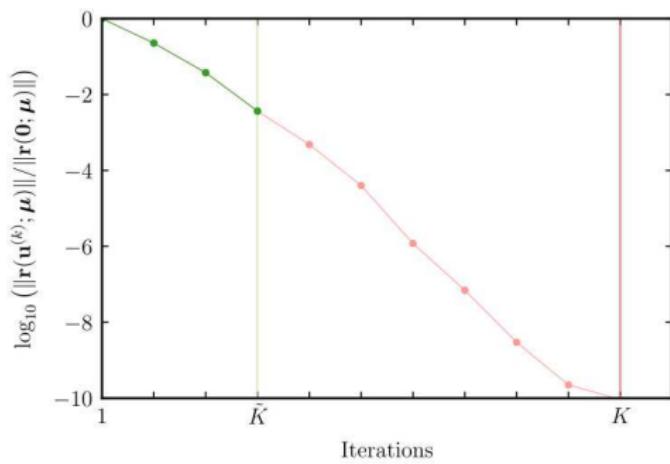
Inexact Solutions

- Iterative solution to nonlinear equations: sequence of approximations

$$\mathbf{u}^{(k)}, \quad k = 0, \dots, K$$

- Approximate solution $\mathbf{u}^{(\tilde{K})}$ can be obtained after iteration \tilde{K}

$$\tilde{\mathbf{u}}(\mu) = \mathbf{u}^{(\tilde{K})}$$

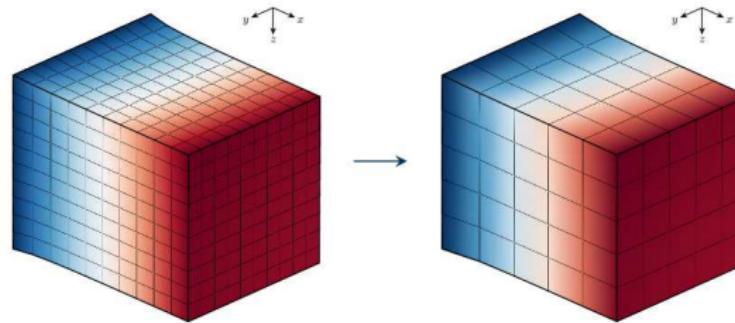


Lower-Fidelity Models

Fidelity reduction approaches

- Neglect physical phenomena
- Reduce spatial accuracy
 - Use lower-order finite differences or elements
 - Coarsen the mesh and prolongate (interpolate) the solution

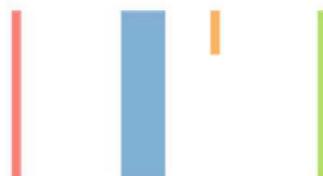
$$\tilde{\mathbf{u}} = \mathbf{p}(\mathbf{u}_{\text{LF}}), \quad \mathbf{p} : \mathbb{R}^{N_{\mathbf{u}_{\text{LF}}}} \rightarrow \mathbb{R}^{N_{\mathbf{u}}}$$



Model Reduction

Model reduction restricts approximate solution $\tilde{\mathbf{u}}$ to $m_{\mathbf{u}}$ -dimensional affine trial subspace $\text{Ran}(\Phi_{\mathbf{u}}) + \bar{\mathbf{u}} \subseteq \mathbb{R}^{N_{\mathbf{u}}}$ with $m_{\mathbf{u}} \ll N_{\mathbf{u}}$:

$$\tilde{\mathbf{u}}(\boldsymbol{\mu}) = \Phi_{\mathbf{u}} \hat{\mathbf{u}}(\boldsymbol{\mu}) + \bar{\mathbf{u}}$$



- $\Phi_{\mathbf{u}} \in \mathbb{R}_{*}^{N_{\mathbf{u}} \times m_{\mathbf{u}}}$ trial basis, computed using
 - proper orthogonal decomposition (POD)
 - the reduced-basis method
 - variants that employ gradient information
- $\hat{\mathbf{u}} : \mathbb{R}^{N_{\boldsymbol{\mu}}} \rightarrow \mathbb{R}^{m_{\mathbf{u}}}$ generalized coordinates of the approx. solution
- $\bar{\mathbf{u}} \in \mathbb{R}^{N_{\mathbf{u}}}$ prescribed reference state

Model Reduction (continued)

- $\mathbf{r}(\Phi_{\mathbf{u}}\hat{\mathbf{u}}(\boldsymbol{\mu}) + \bar{\mathbf{u}}; \boldsymbol{\mu}) = \mathbf{0}$ is **overdetermined**: $N_{\mathbf{u}}$ equations, $m_{\mathbf{u}}$ unknowns
- Second step projects residual onto an $m_{\mathbf{u}}$ -dimensional test subspace $\text{Ran}(\Psi_{\mathbf{u}}) \subseteq \mathbb{R}^{N_{\mathbf{u}}}$:

$$\Psi_{\mathbf{u}}^T \mathbf{r}(\Phi_{\mathbf{u}} \hat{\mathbf{u}}(\mu) + \bar{\mathbf{u}}; \mu) = 0$$



- $\Psi_u \in \mathbb{R}_*^{N_u \times m_u}$ test basis, common choices include
 - Galerkin projection: $\Psi_u = \Phi_u$
 - Least-squares Petrov–Galerkin projection: $\Psi_u = \frac{\partial \mathbf{r}}{\partial \mathbf{v}}(\Phi_u \hat{\mathbf{u}}(\boldsymbol{\mu}) + \bar{\mathbf{u}}; \boldsymbol{\mu}) \Phi_u$

Approaches for Error Quantification

- Regardless of approach, it is essential to quantify error incurred by employing approximate solution $\tilde{\mathbf{u}}$ in lieu of exact solution \mathbf{u}
- Existing approaches include
 - Data-fit mapping between parameters and the error
 - Inspired by multifidelity design optimization
 - Reduced-Order Model Error Surrogates (ROMES) method
 - M. Drohmann and K. Carlberg, 2015
 - Quantity-of-interest error approximated using dual-weighted residuals
 - Normed state-space error approx. using residual norm and error bounds
- This work focuses on quantifying two errors:
 - 1) Error in quantity of interest: $\delta_s(\boldsymbol{\mu}) := s(\boldsymbol{\mu}) - \tilde{s}(\boldsymbol{\mu})$
 - 2) Normed state-space error: $\delta_{\mathbf{u}}(\boldsymbol{\mu}) := \|\mathbf{e}(\boldsymbol{\mu})\|_2$, where $\mathbf{e}(\boldsymbol{\mu}) := \mathbf{u}(\boldsymbol{\mu}) - \tilde{\mathbf{u}}(\boldsymbol{\mu})$

State-Space Error

The residual can be approximated about the approximate solution $\tilde{\mathbf{u}}$:

$$\mathbf{r}(\mathbf{u}(\boldsymbol{\mu}); \boldsymbol{\mu}) = \mathbf{0} = \mathbf{r}(\boldsymbol{\mu}) + \mathbf{J}(\boldsymbol{\mu})\mathbf{e}(\boldsymbol{\mu}) + \mathcal{O}(\|\mathbf{e}(\boldsymbol{\mu})\|^2)$$

and rearranged to approximate the state-space error:

$$\mathbf{e}(\boldsymbol{\mu}) = -\mathbf{J}(\boldsymbol{\mu})^{-1}\mathbf{r}(\boldsymbol{\mu}) + \mathcal{O}(\|\mathbf{e}(\boldsymbol{\mu})\|^2)$$

- $\mathbf{r}(\boldsymbol{\mu}) := \mathbf{r}(\tilde{\mathbf{u}}(\boldsymbol{\mu}); \boldsymbol{\mu}) \in \mathbb{R}^{N_{\mathbf{u}}}$ residual from approximate solution
- $\mathbf{J}(\boldsymbol{\mu}) := \frac{\partial \mathbf{r}}{\partial \mathbf{v}}(\tilde{\mathbf{u}}(\boldsymbol{\mu}); \boldsymbol{\mu}) \in \mathbb{R}^{N_{\mathbf{u}} \times N_{\mathbf{u}}}$ Jacobian of residual at $\tilde{\mathbf{u}}(\boldsymbol{\mu})$

Error in the Quantity of Interest

The quantity of interest also can be approximated:

$$s(\boldsymbol{\mu}) = \tilde{s}(\boldsymbol{\mu}) + \frac{\partial g}{\partial \mathbf{u}}(\tilde{\mathbf{u}}(\boldsymbol{\mu}))\mathbf{e}(\boldsymbol{\mu}) + \mathcal{O}(\|\mathbf{e}(\boldsymbol{\mu})\|^2)$$

and combined with the state-space error approximation to yield

$$\delta_s(\boldsymbol{\mu}) = \underbrace{-\frac{\partial g}{\partial \mathbf{v}}(\tilde{\mathbf{u}}(\boldsymbol{\mu})) \mathbf{J}(\boldsymbol{\mu})^{-1} \mathbf{r}(\boldsymbol{\mu})}_{\mathbf{y}(\boldsymbol{\mu})^T} + \mathcal{O}(\|\mathbf{e}(\boldsymbol{\mu})\|^2)$$

- $y(\mu)$ is the dual or adjoint
- dual-weighted residual d is weighted sum of residual elements:

$$d(\boldsymbol{\mu}) := \mathbf{y}(\boldsymbol{\mu})^T \mathbf{r}(\boldsymbol{\mu}) = \sum_{i=1}^{N_u} y_i(\boldsymbol{\mu}) r_i(\boldsymbol{\mu})$$

Drawbacks to using the Dual-Weighted Residual

- **Computational Cost:** requires solving $N_{\mathbf{u}}$ linear equations
- **Implementation:** requires Jacobian – not always available
- **Uncertainty Quantification:** low-bias error estimate not assured

Nonetheless, structure provides insight into quantity-of-interest error

Normed State-Space Error

- Residual-based bounds commonly used *a posteriori* to quantify $\delta_{\mathbf{u}}(\boldsymbol{\mu})$
A. Buffa et al., 2012; M. A. Grepl and A. T. Patera, 2005; G. Rozza et al., 2008
- Assuming Lipschitz continuity for the residual $\mathbf{r}(\cdot; \boldsymbol{\mu})$, then

$$\frac{\|\mathbf{r}(\boldsymbol{\mu})\|}{\beta(\boldsymbol{\mu})} \leq \delta_{\mathbf{u}}(\boldsymbol{\mu}) \leq \frac{\|\mathbf{r}(\boldsymbol{\mu})\|}{\alpha(\boldsymbol{\mu})},$$

where α and β are Lipschitz constants

- Drawbacks to using error bounds
 - **Sharpness:** upper/lower bounds can overpredict/underpredict actual error by several orders of magnitude
 - **Implementation:** difficult to compute true Lipschitz constants
 - **Uncertainty Quantification:** do not produce statistical distribution over $\delta_{\mathbf{u}}(\boldsymbol{\mu})$ – cannot quantify epistemic uncertainty

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Overview

- We aim to construct statistical models of
 - quantity-of-interest error δ_s
 - normed state-space error $\delta_{\mathbf{u}}$
- We apply high-dimensional regression methods from machine learning
- We use a larger number of **inexpensive** error indicators, resulting in **less costly**, more **accurate** error models

Error Model

- Assume there exist N_x *error indicators* or *features* $\mathbf{x}(\boldsymbol{\mu}) \in \mathbb{R}^{N_x}$
 - available from solution approximation
 - cheaply computable
 - informative of the error $\delta(\boldsymbol{\mu}) \in \mathbb{R}$
- We model the nondeterministic mapping $\mathbf{x}(\boldsymbol{\mu}) \mapsto \delta(\boldsymbol{\mu})$

$$\delta(\boldsymbol{\mu}) = f(\mathbf{x}(\boldsymbol{\mu})) + \epsilon(\mathbf{x}(\boldsymbol{\mu}))$$

- f : deterministic regression function
- ϵ : stochastic noise
 - Mean-zero random variable
 - Accounts for irreducible error due to omitted explanatory variables
 - Epistemic – additional features can enable zero noise

Regression Model

- Regression function defines conditional expectation of error given the features:

$$E[\delta(\boldsymbol{\mu}) \mid \mathbf{x}(\boldsymbol{\mu})] = f(\mathbf{x}(\boldsymbol{\mu}))$$

- We construct models of

- deterministic regression function $\hat{f}(\approx f)$
- stochastic noise $\hat{\epsilon}(\approx \epsilon)$,

which yield a statistical model for the approximate-solution error

$$\hat{\delta}(\boldsymbol{\mu}) = \hat{f}(\mathbf{x}(\boldsymbol{\mu})) + \hat{\epsilon}(\mathbf{x}(\boldsymbol{\mu}))$$

Regression Model Objectives

- **Low Cost:** Should employ cheaply computable features \mathbf{x}
- **Low Noise Variance:** Should exhibit low noise variance, reduce epistemic uncertainty introduced by approximate solution
- **Generalize:** Empirical distributions of $\hat{\delta}$ and δ should be close on test set **not** used to train model – should not overfit on training data

Regression Model Construction Steps

1) Feature engineering

- Cheaply computable features \mathbf{x} from approximate model
- Informative of the error – construct low-noise-variance model
- Low dimensional (small $N_{\mathbf{x}}$) such that less training data is needed

2) Regression-function approximation

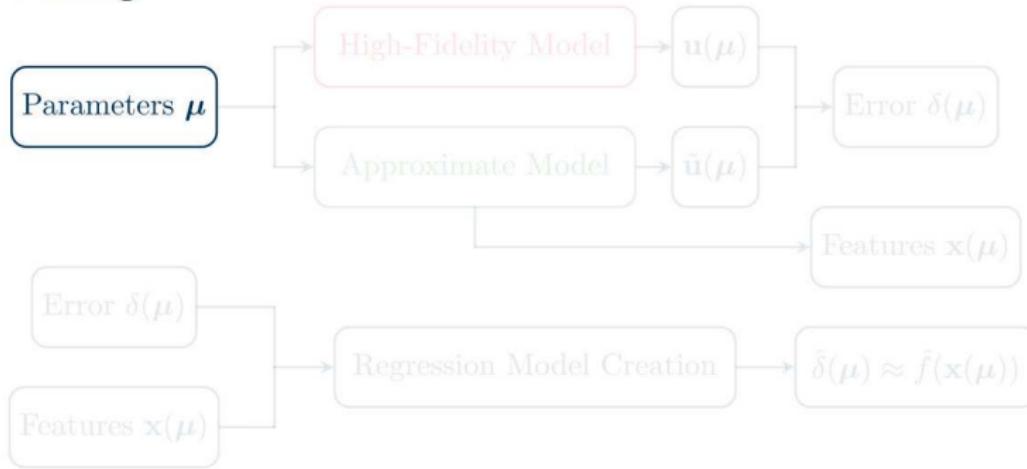
- Construct \hat{f} using regression methods from machine learning
- Approximate mapping from features \mathbf{x} to error δ using a training set

3) Noise approximation

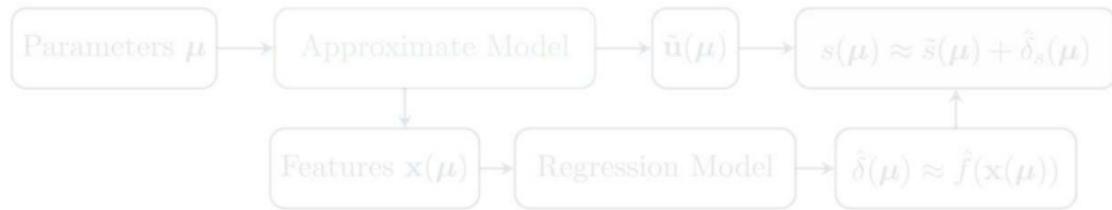
- Mean-zero, constant-variance Gaussian random variable: $\hat{\epsilon} \sim \mathcal{N}(0, \hat{\sigma}^2)$
- $\hat{\sigma}^2$ is sample variance of regression-model noise on a test set
(mean squared error on test set)

Summary

Training

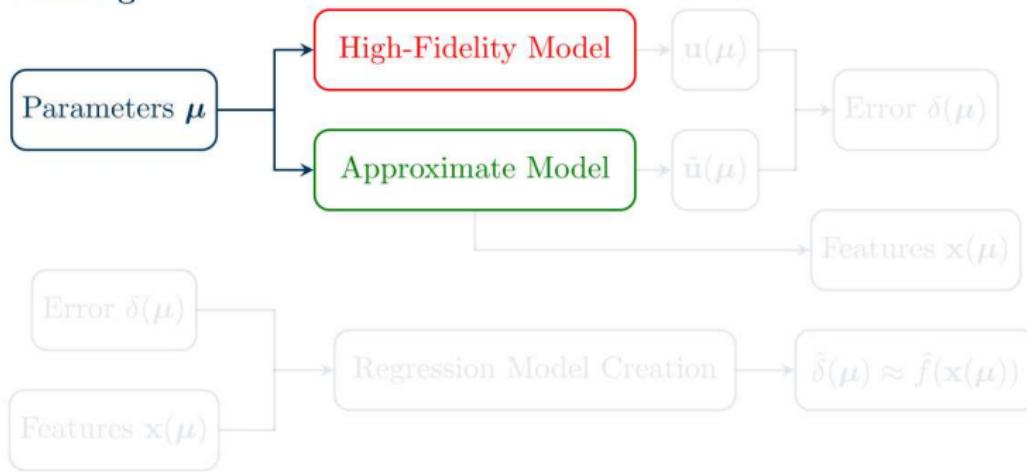


Application

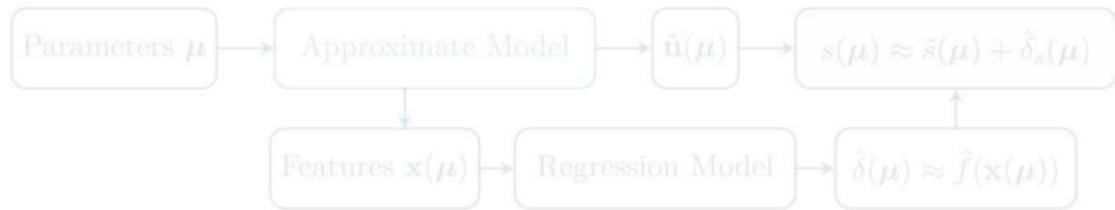


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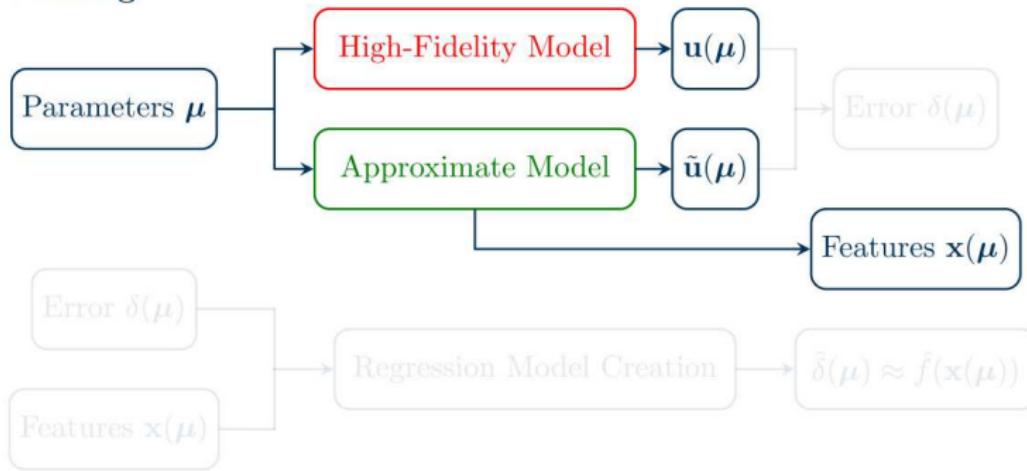


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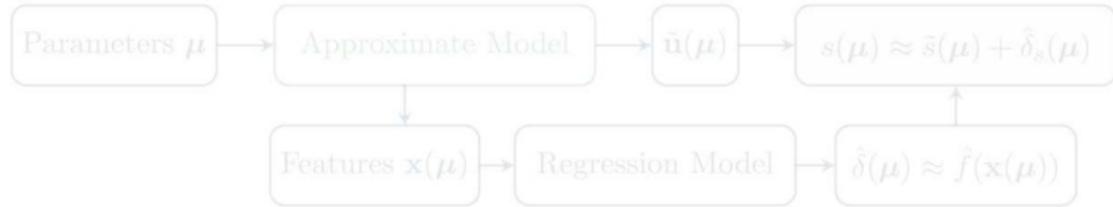


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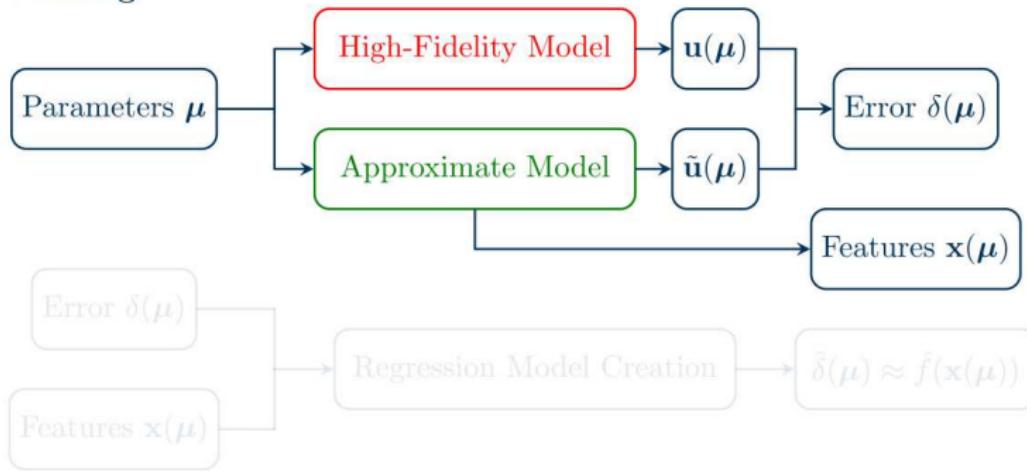


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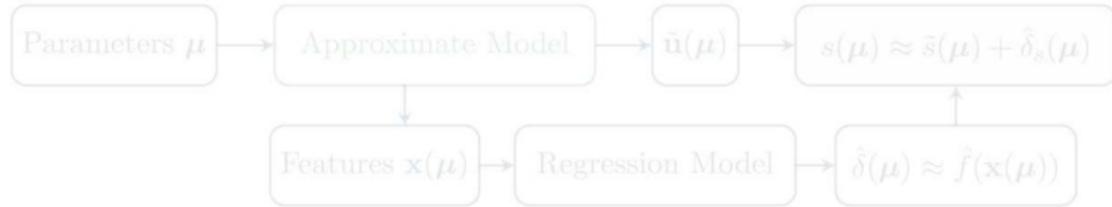


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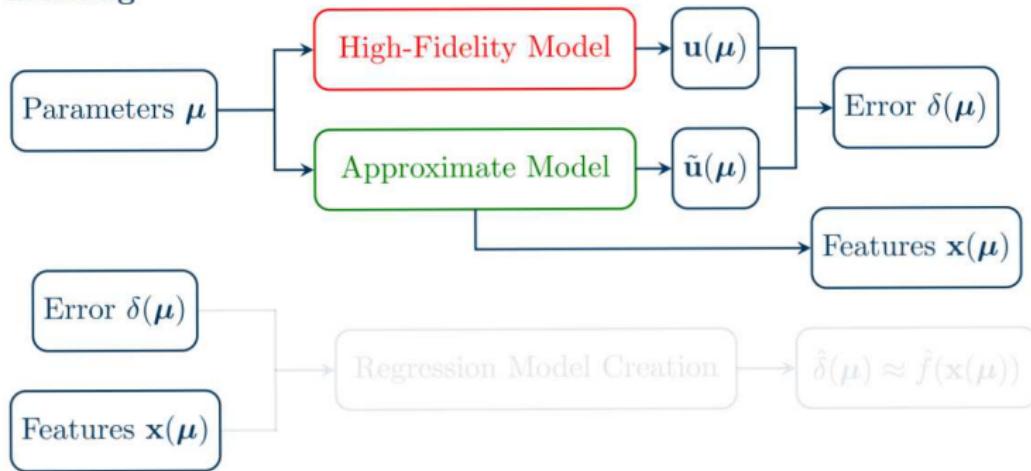


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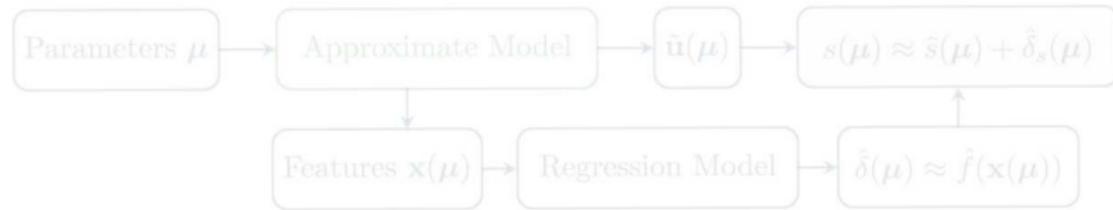


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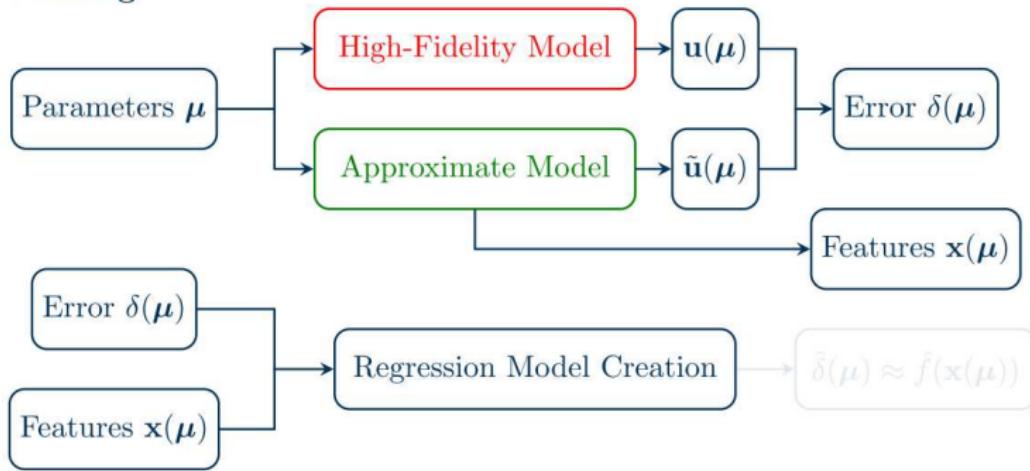


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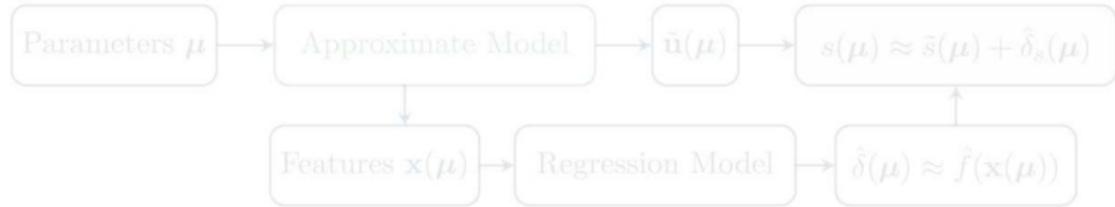


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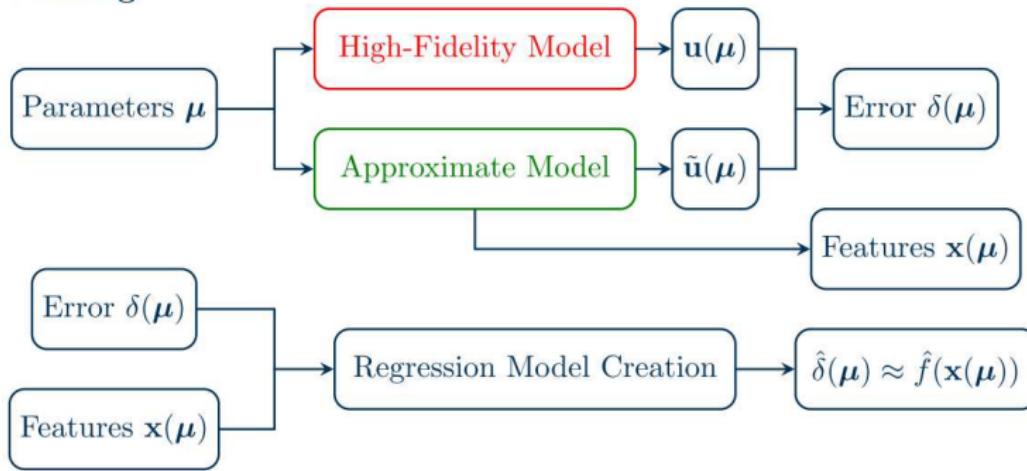


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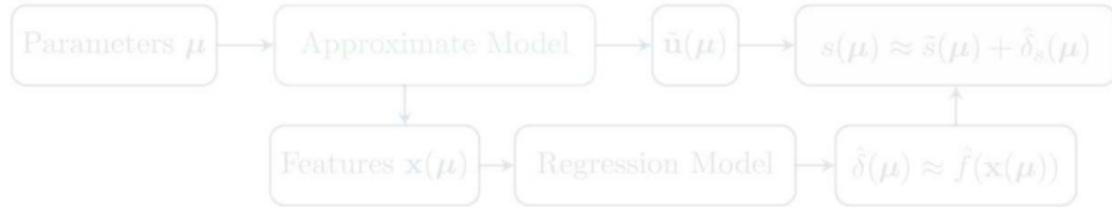


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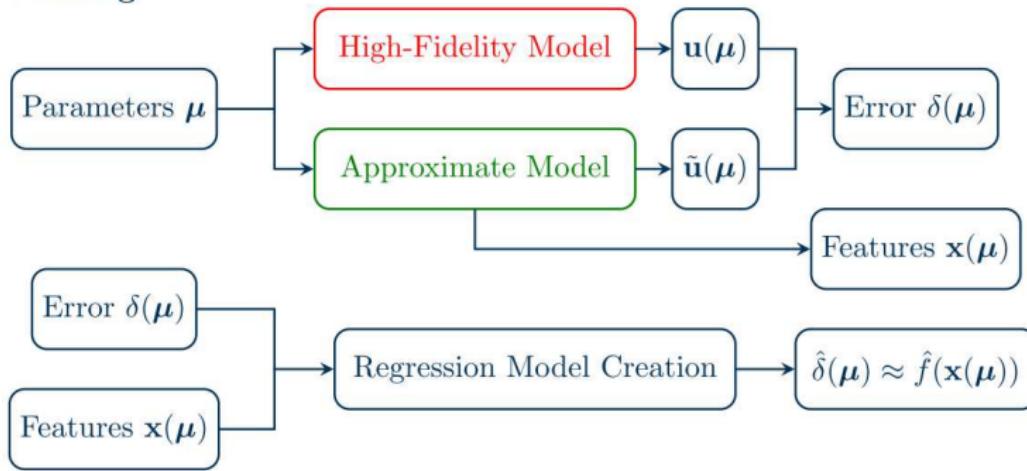


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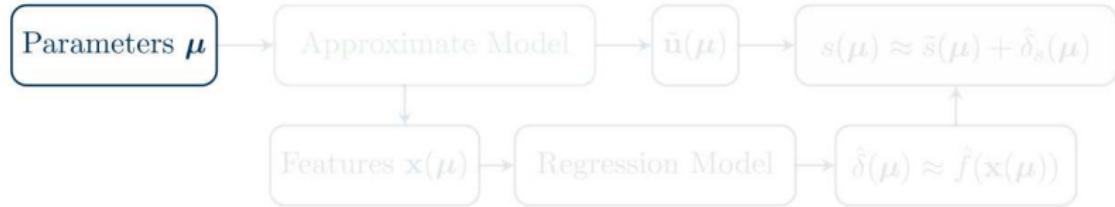


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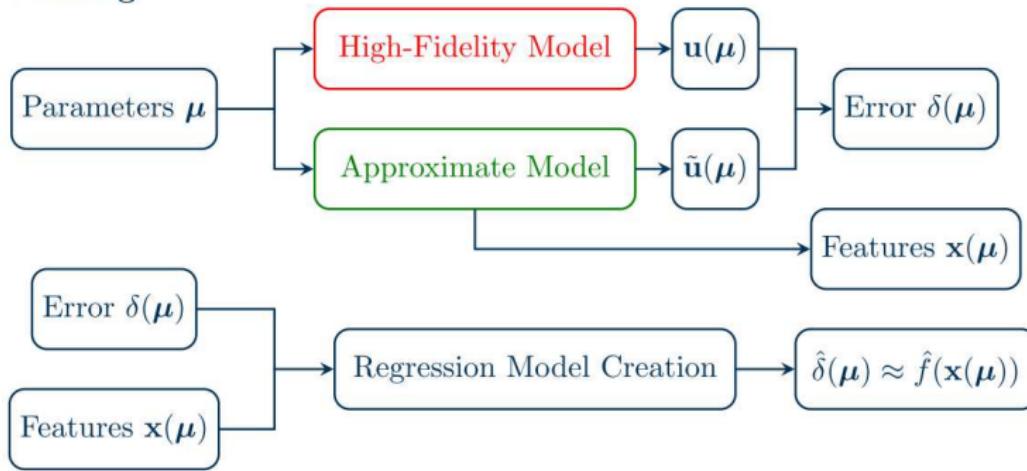


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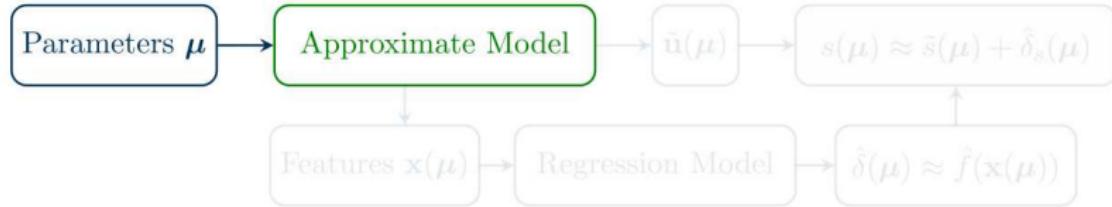


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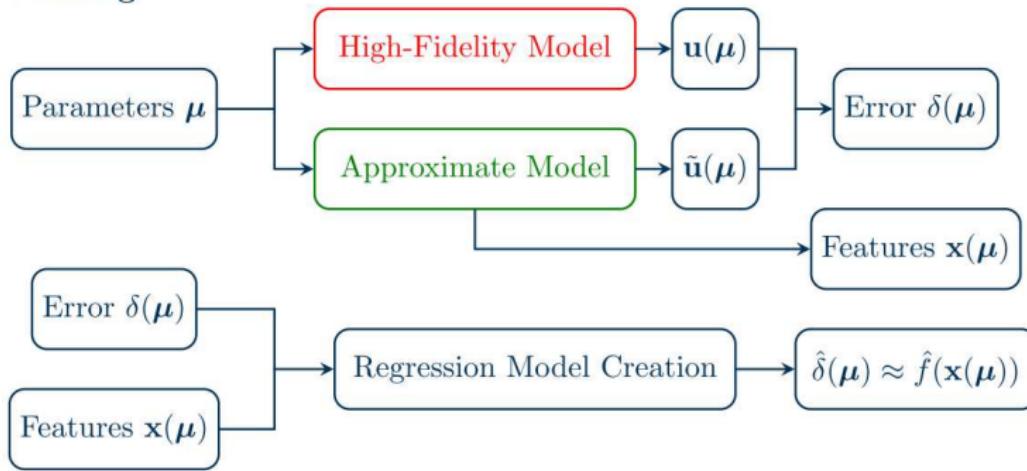


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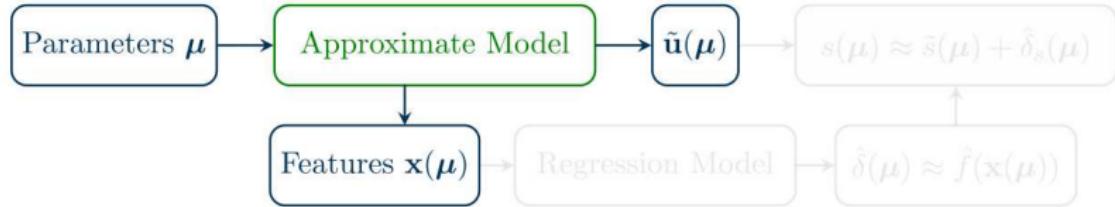


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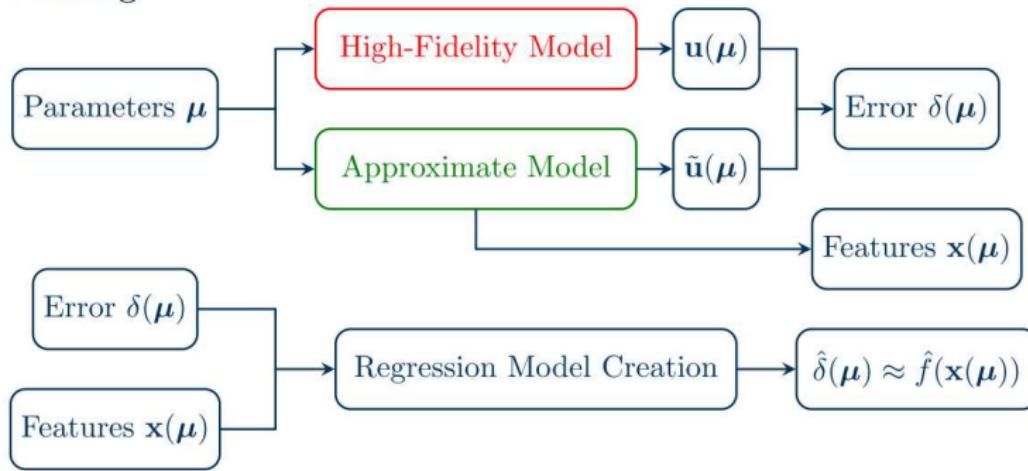


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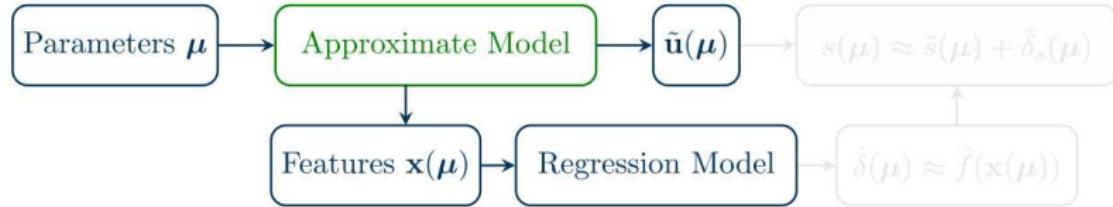


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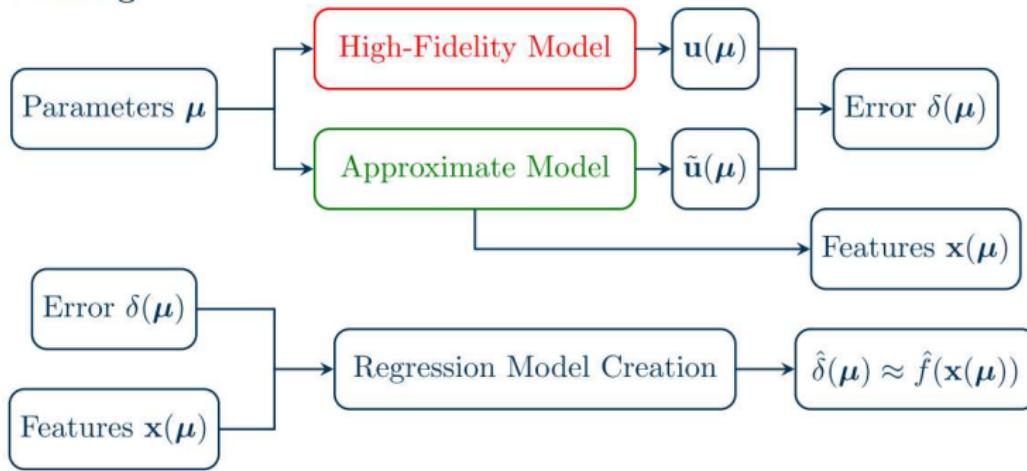


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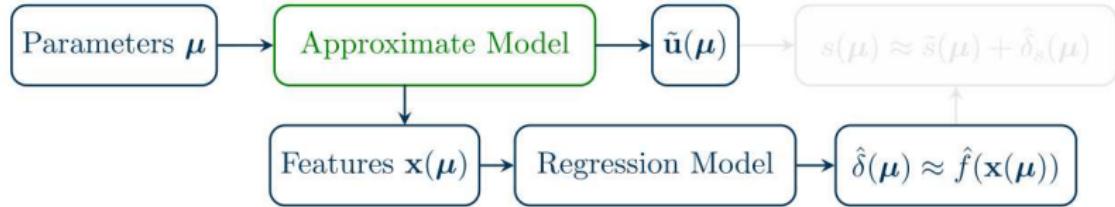


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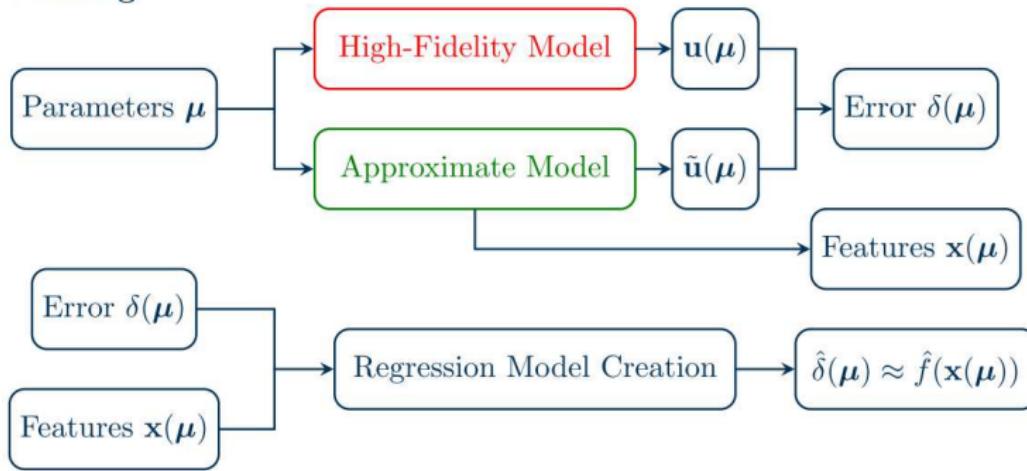


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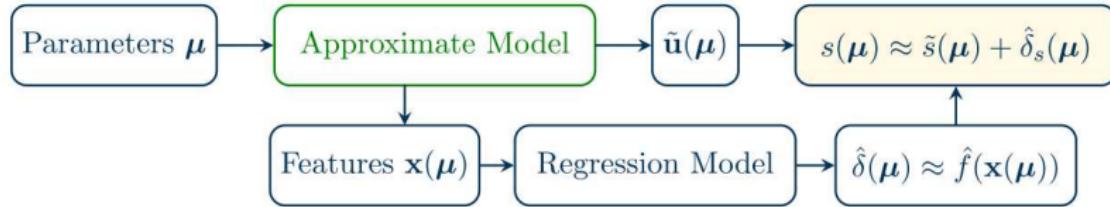


Summary

Training



Application



Feature Engineering: Parameters

$$\mathbf{x}(\boldsymbol{\mu}) = \boldsymbol{\mu}$$

- The mapping $\boldsymbol{\mu} \mapsto \delta(\boldsymbol{\mu})$ is **deterministic**, but often **complex**
 - Can be **oscillatory** for ROMs since $\delta(\boldsymbol{\mu}) \approx 0$ when $\boldsymbol{\mu} \in \mathcal{D}_{\text{Train}}^{\text{ROM}}$
- Could yield **zero** noise variance if
 - **Large** amount of training data
 - High-capacity regression model
- Typically **low-quality** features
- Inspired by ‘multifidelity correction’ methods for optimization

Alexandrov et al., 2001; Gano et al., 2005; Eldred et al., 2004

Feature Engineering: Dual-Weighted Residual

$$\mathbf{x}(\boldsymbol{\mu}) = d(\boldsymbol{\mu}) := \mathbf{y}(\boldsymbol{\mu})^T \mathbf{r}(\boldsymbol{\mu})$$

- First-order approximation of QoI error $\delta_s(\boldsymbol{\mu})$
- Small number ($N_{\mathbf{x}} = 1$) of high-quality features
- High computational cost and significant implementation effort
- ROMES method uses approximation for dual-weighted residual

M. Drohmann and K. Carlberg, 2015

Feature Engineering: Parameters and Residual (Approximations)

$$\mathbf{x}(\boldsymbol{\mu}) = [\boldsymbol{\mu}; \mathbf{r}(\boldsymbol{\mu})]$$

- DWR is weighted sum of residual vector elements $d(\boldsymbol{\mu}) := \mathbf{y}(\boldsymbol{\mu})^T \mathbf{r}(\boldsymbol{\mu})$
- **Avoids** implementation and costs associated with dual vector $\mathbf{y}(\boldsymbol{\mu})$
- **Large number** ($N_{\mathbf{x}} = N_{\boldsymbol{\mu}} + N_{\mathbf{u}}$) of **low-quality** features
- Approaches to **reduce** number of features and **improve** quality
 - Use $m_{\mathbf{r}} \ll N_{\mathbf{u}}$ principal component coefficients: $\hat{\mathbf{r}}(\boldsymbol{\mu})$
 - Sample $n_{\mathbf{r}} \ll N_{\mathbf{u}}$ elements of residual: $\mathbf{Pr}(\boldsymbol{\mu})$, where $\mathbf{P} \in \{0, 1\}^{n_{\mathbf{r}} \times N_{\mathbf{u}}}$
 - Use $m_{\mathbf{r}} \ll N_{\mathbf{u}}$ gappy principal component coefficients: $\hat{\mathbf{r}}_g(\boldsymbol{\mu})$

Feature Engineering: Residual Norm with/without Parameters

$$\mathbf{x}(\boldsymbol{\mu}) = \|\mathbf{r}(\boldsymbol{\mu})\| \quad \text{or} \quad \mathbf{x}(\boldsymbol{\mu}) = [\boldsymbol{\mu}; \|\mathbf{r}(\boldsymbol{\mu})\|]$$

- DWR can be bounded using the Cauchy–Schwarz inequality:

$$|d(\boldsymbol{\mu})| \leq \|\mathbf{y}(\boldsymbol{\mu})\|_2 \|\mathbf{r}(\boldsymbol{\mu})\|$$

- Normed state-space error $\delta_{\mathbf{u}}(\boldsymbol{\mu})$ can be bounded:

M. Drohmann and K. Carlberg, 2015

$$\frac{\|\mathbf{r}(\boldsymbol{\mu})\|}{\beta(\boldsymbol{\mu})} \leq \delta_{\mathbf{u}}(\boldsymbol{\mu}) \leq \frac{\|\mathbf{r}(\boldsymbol{\mu})\|}{\alpha(\boldsymbol{\mu})}$$

- $\boldsymbol{\mu}$ can be omitted ($\mathbf{x}(\boldsymbol{\mu}) = \|\mathbf{r}(\boldsymbol{\mu})\|$) if
 - $\boldsymbol{\mu}$ is not indicative of error
 - $N_{\boldsymbol{\mu}}$ is too large relative to training data
- Requires computing **entire** residual vector $\mathbf{r}(\boldsymbol{\mu})$
- **Small number of potentially low-quality** features

Regression-Function Approximation

We consider several different regression models

- Ordinary least squares (OLS)
 - Linear (OLS: Linear)
 - Quadratic expansion of features (OLS: Quadratic)
- Support vector regression (SVR)
 - Linear kernel (SVR: Linear)
 - Gaussian (radial basis function) kernel (SVR: RBF)
- Random forest (RF)
- k -nearest neighbors (k -NN)
- Artificial neural network (ANN)

Training and Test Data

Training Data

- Set of parameter training instances $\mathcal{D}_{\text{train}} \subset \mathcal{D}$
- Train regression models from high-fidelity and approx. solutions
 - Cross-validated to tune regression-model hyper-parameters
- Used to compute principal components of residuals

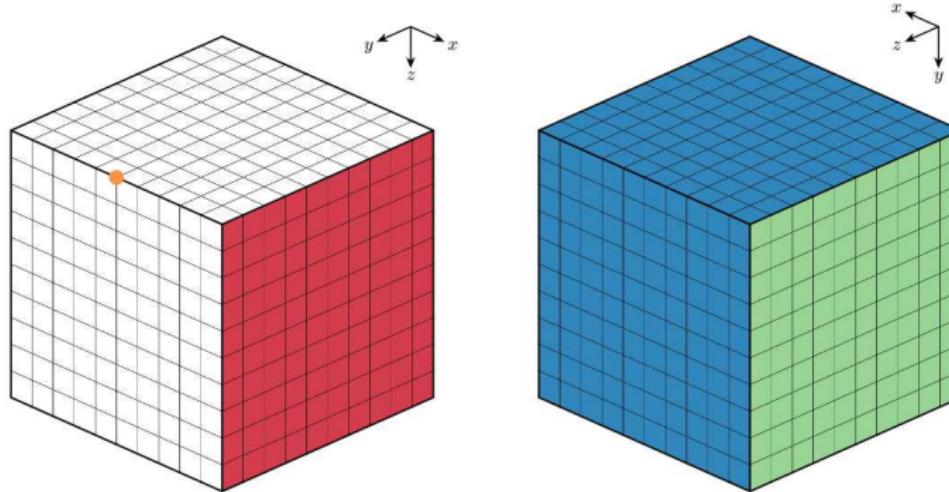
Test Data

- Set of parameter test instances $\mathcal{D}_{\text{test}} \subset \mathcal{D}$ **not** used for training ($\mathcal{D}_{\text{train}} \cap \mathcal{D}_{\text{test}} = \emptyset$)
- Used to assess regression models and quantify stochastic noise

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 - PCAP: Reduced-Order Modeling
 - Burgers' Equation: Inexact Solutions and Coarse Solution Prolongation
- Summary

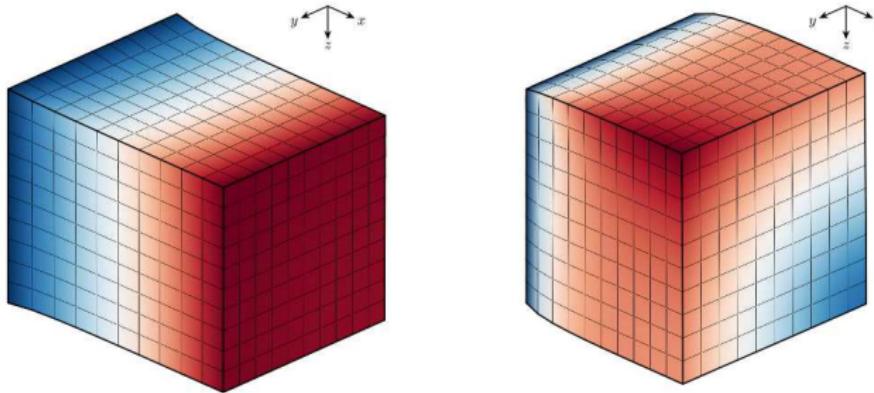
Cube: Reduced-Order Modeling



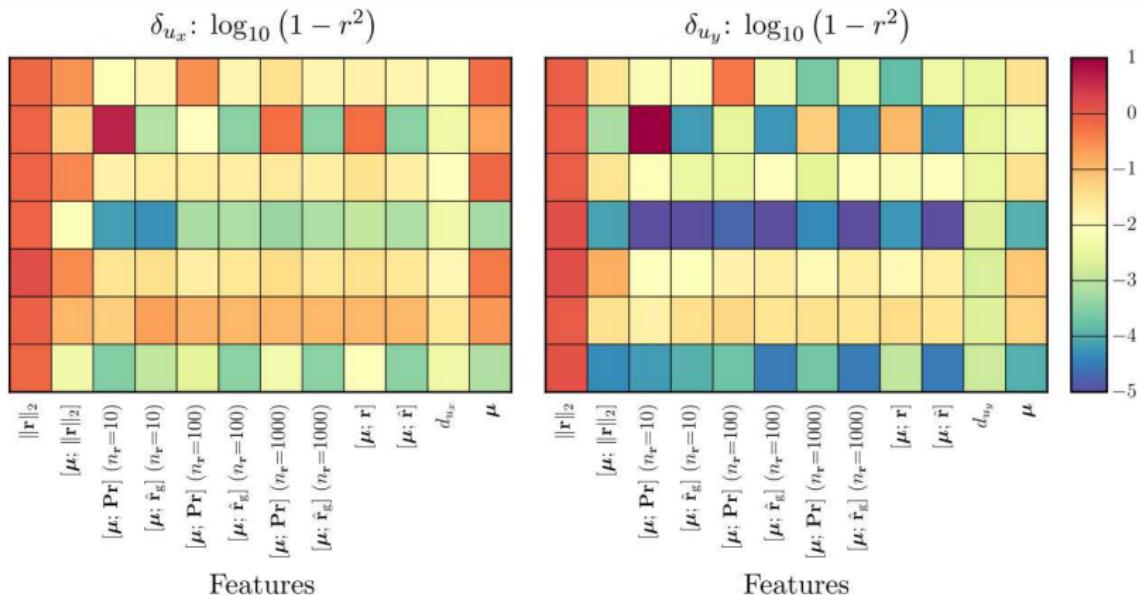
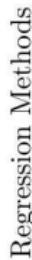
- Applied traction (Neumann boundary condition)
- Planar constraint (Dirichlet boundary condition)
- Complete constraint (Dirichlet boundary condition)
- Node of interest

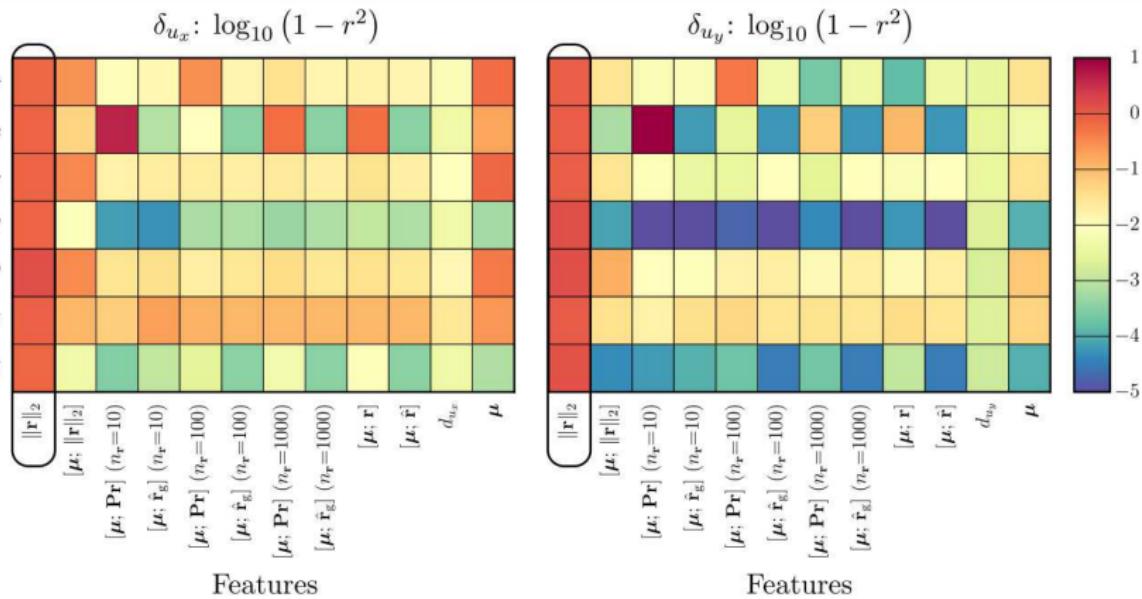
Cube: Overview

- $N_u = 3410$ – deliberately small to compute $d(\mu)$ and use $\mathbf{r}(\mu)$
- $N_\mu = 3$ parameters: $\mu = [E; \nu; t]$
 - $E \in [75, 125]$ GPa, $\nu \in [0.20, 0.35]$, $t \in [40, 60]$ GPa
- 8 HF runs \rightarrow up to $m_u = 8$ ROM basis functions (2 used – 99.49%)



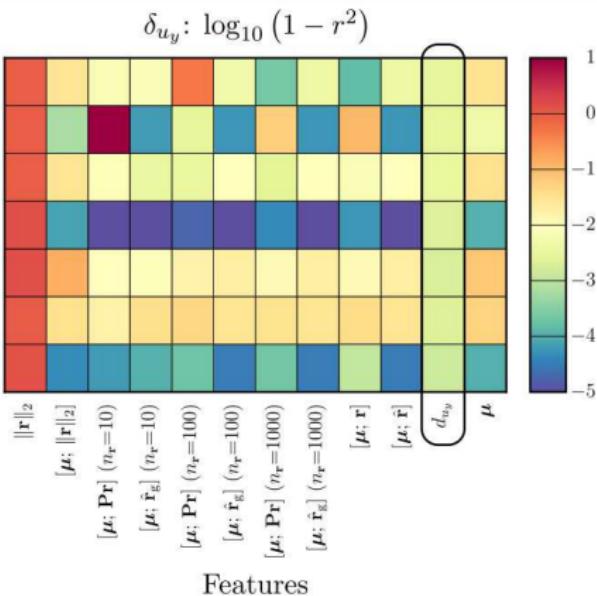
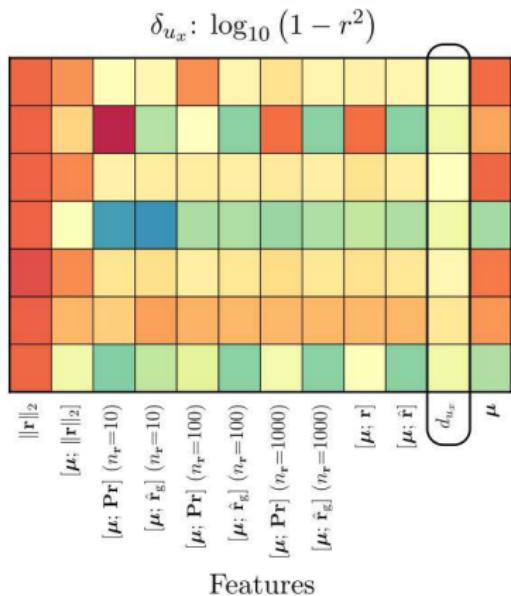
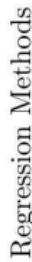
Cube: Variance Unexplained for QoI Error Prediction





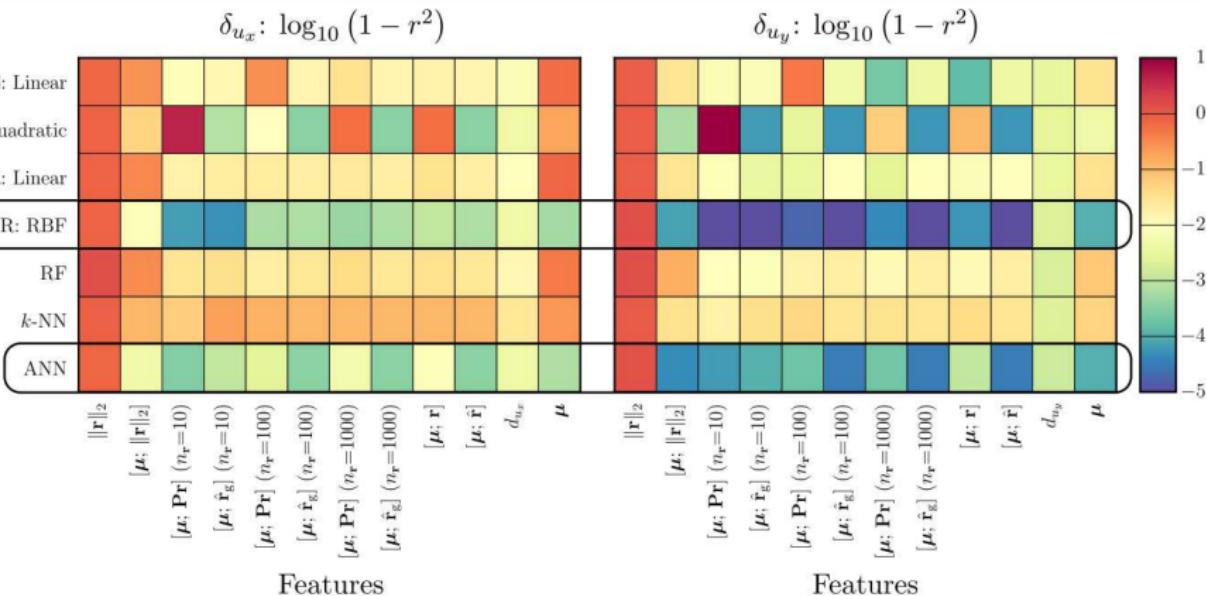
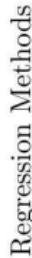
- $\|\mathbf{r}\|$ yields highest variance unexplained

Cube: Variance Unexplained for QoI Error Prediction



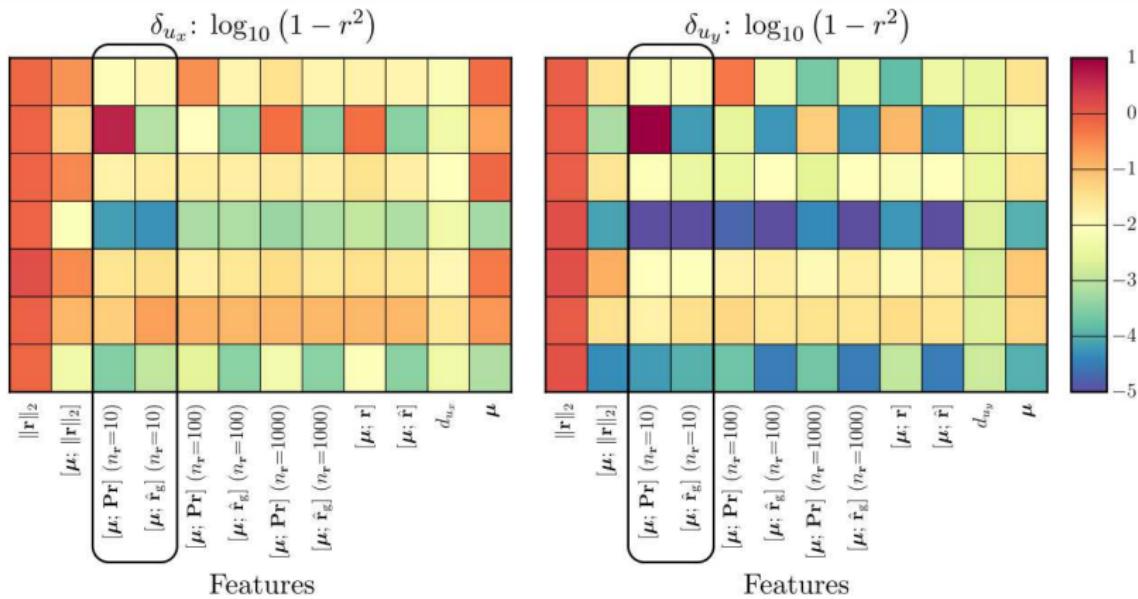
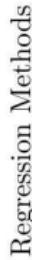
- $\|r\|$ yields highest variance unexplained
- d_{u_x} and d_{u_y} yield moderate variance unexplained, but are costly

Cube: Variance Unexplained for QoI Error Prediction



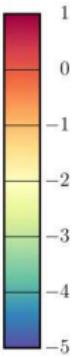
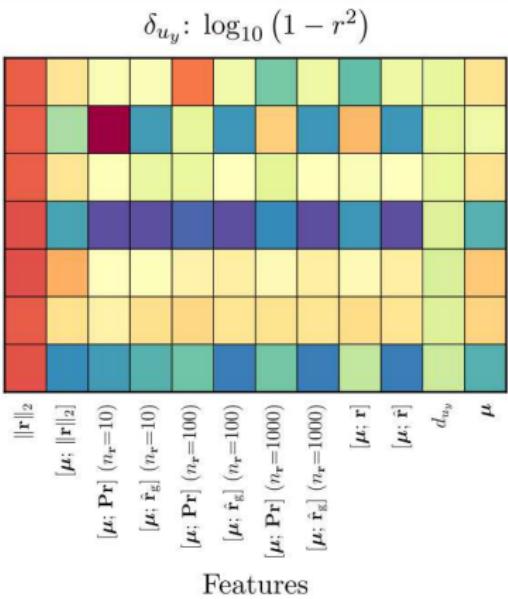
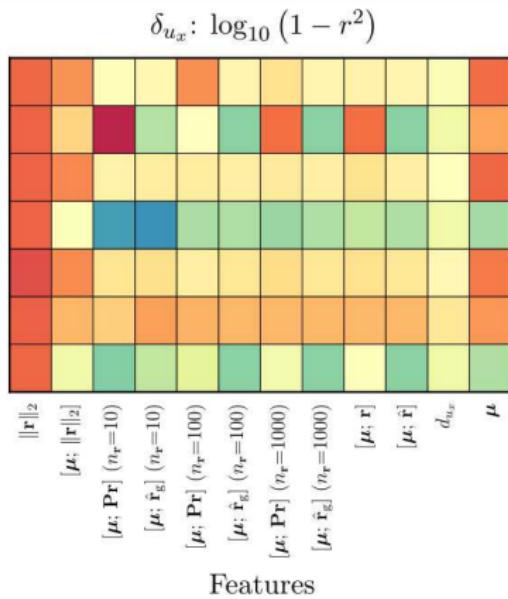
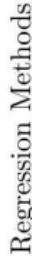
- $\|r\|$ yields highest variance unexplained
- d_{ux} and d_{uy} yield moderate variance unexplained, but are costly
- SVR: RBF and ANN yield lowest variance unexplained

Cube: Variance Unexplained for QoI Error Prediction



- $\|\mathbf{r}\|$ yields highest variance unexplained
- d_{u_x} and d_{u_y} yield moderate variance unexplained, but are costly
- SVR: RBF and ANN yield lowest variance unexplained
- $[\boldsymbol{\mu}; \hat{\mathbf{r}}_g]$ and $[\boldsymbol{\mu}; \mathbf{Pr}]$ yield low variance unexplained with only 10 samples (compared to $N_{\mathbf{u}} = 3410$)

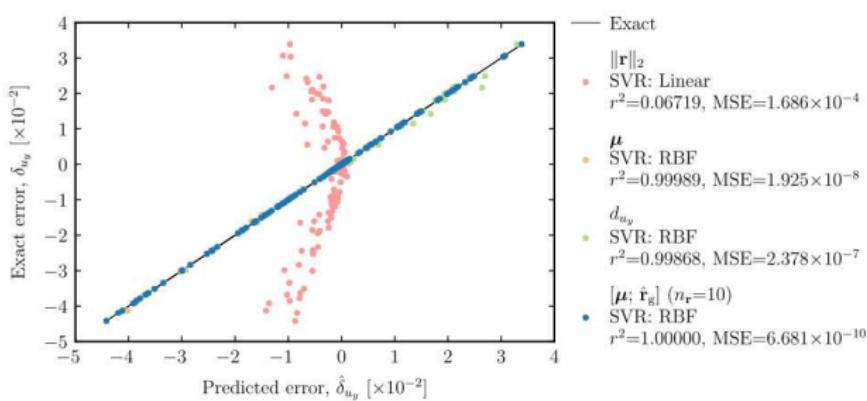
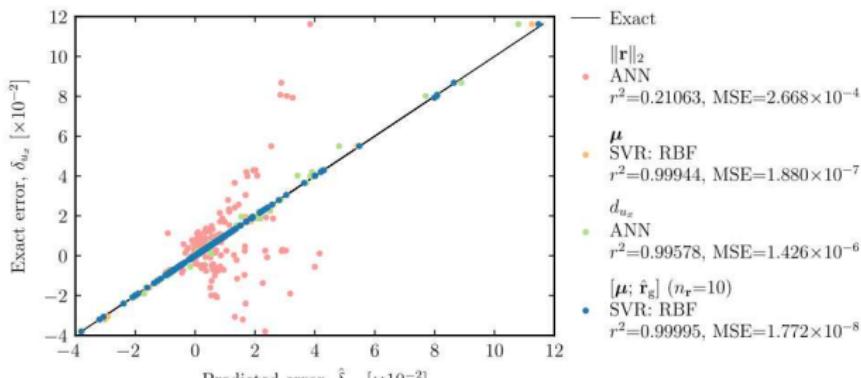
Cube: Variance Unexplained for QoI Error Prediction



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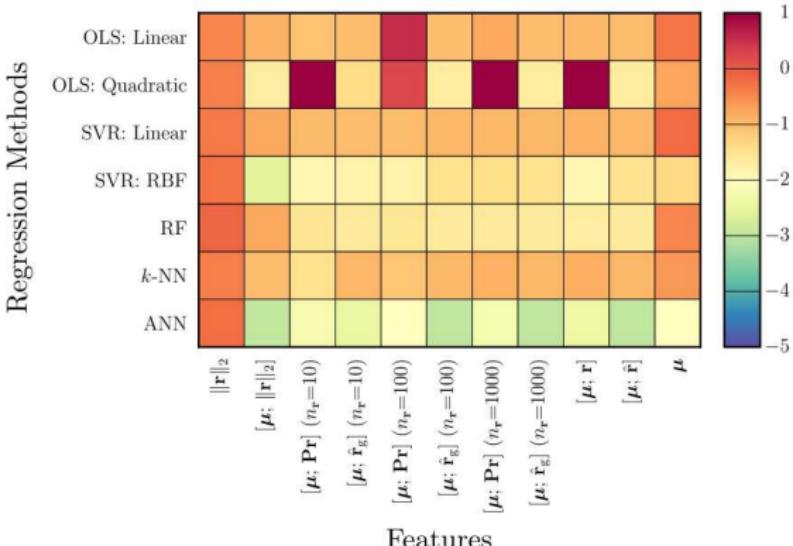
Cube: QoI Error Predictions

- Our method beats previous state-of-the-art methods with $r^2 > 0.9999$ in both cases

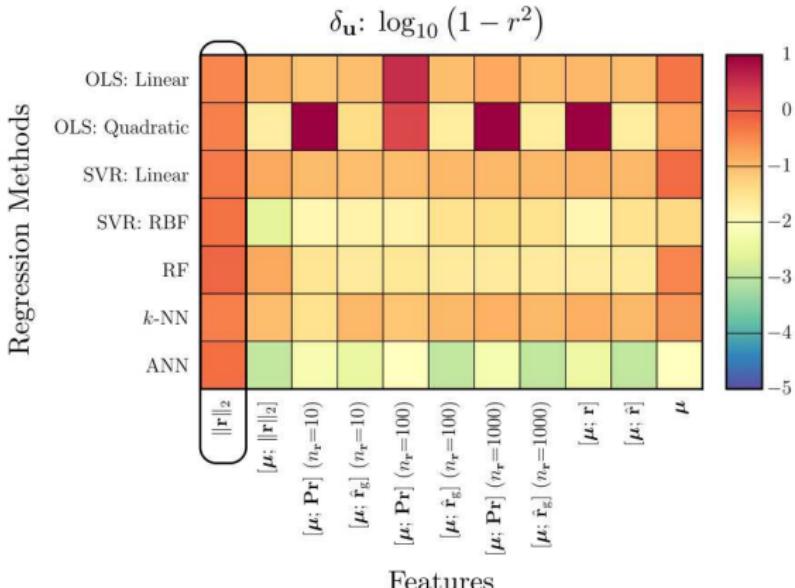


Cube: Variance Unexplained for Normed State-Space Error Prediction

$$\delta_u: \log_{10} (1 - r^2)$$



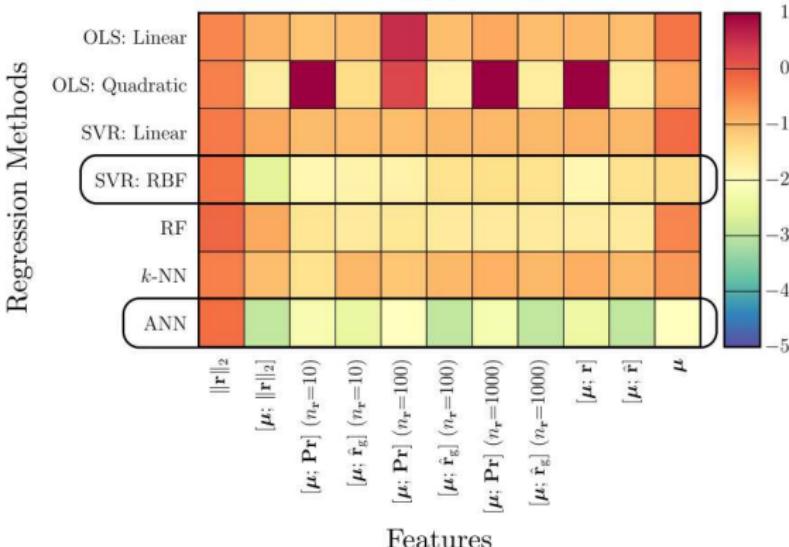
Cube: Variance Unexplained for Normed State-Space Error Prediction



- $\|r\|$ yields highest variance unexplained

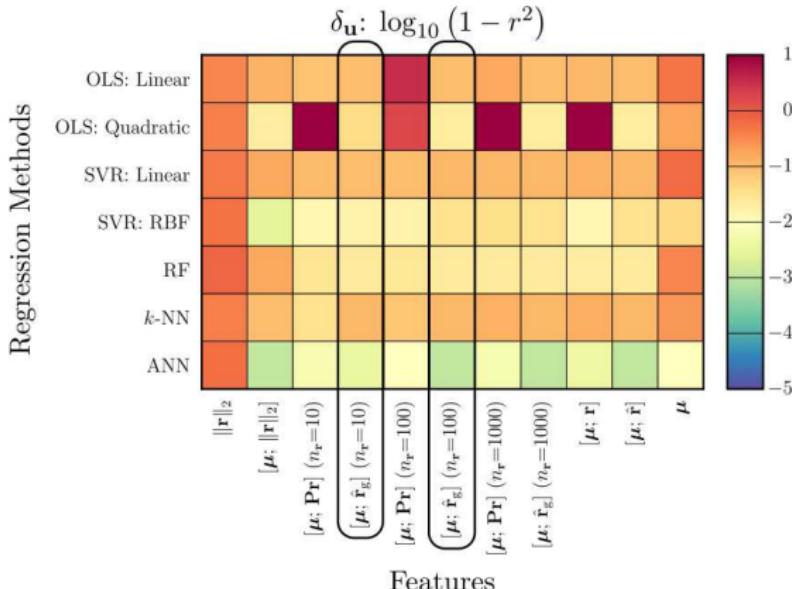
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- $\|r\|$ yields highest variance unexplained
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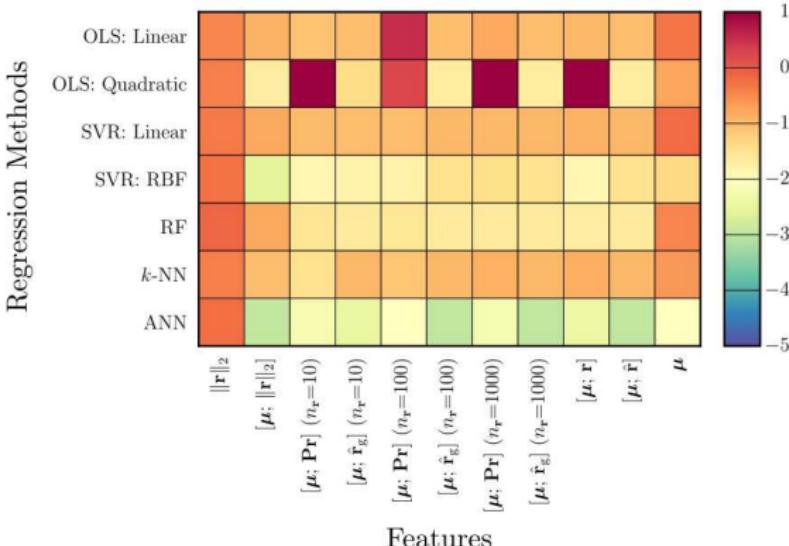
Cube: Variance Unexplained for Normed State-Space Error Prediction



- $\|r\|$ yields highest variance unexplained
- SVR: RBF and ANN yield lowest variance unexplained
- $[\mu; \hat{r}_g]$ yields low variance unexplained with few samples (compared to $N_u = 3410$)

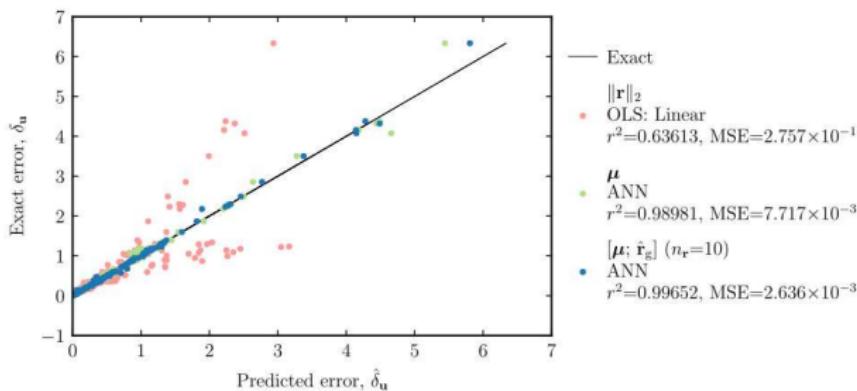
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$$\delta_u: \log_{10} (1 - r^2)$$



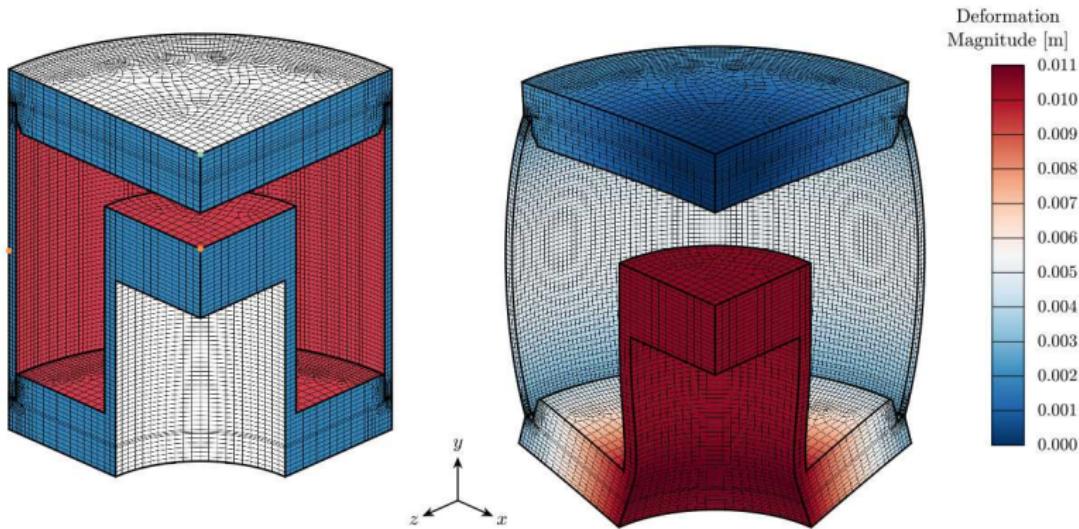
- $\|\mathbf{r}\|$ yields **highest variance unexplained**
- SVR: RBF and ANN yield **lowest variance unexplained**
- $[\mu; \hat{\mathbf{r}}_g]$ yields **low variance unexplained** with **few samples** (compared to $N_u = 3410$)

Cube: Normed State-Space Error Predictions



- Our method beats previous state-of-the-art methods with $r^2 > 0.996$

Predictive Capability Assessment Project: Reduced-Order Modeling

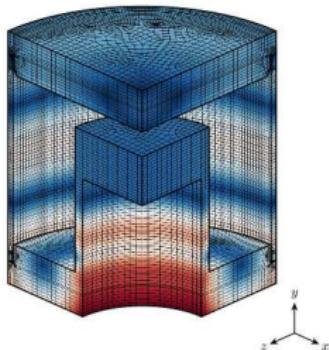
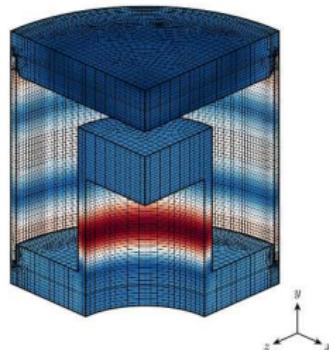
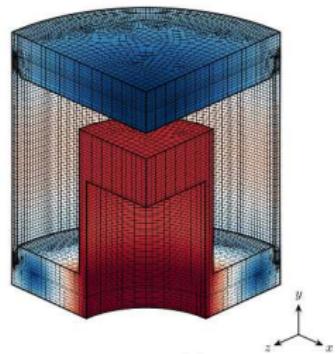
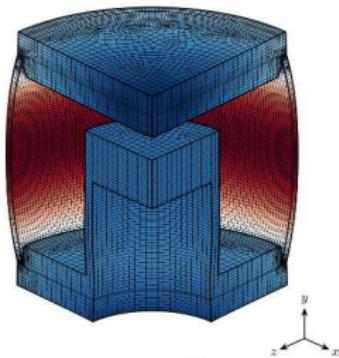
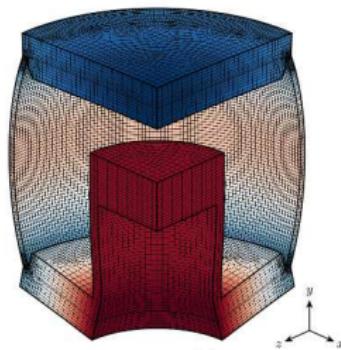


- Applied pressure (Neumann boundary condition)
- Planar constraint (Dirichlet boundary condition)
- Complete constraint (Dirichlet boundary condition)
- Nodes of interest

PCAP: Overview

- $N_{\mathbf{u}} = 274,954$ for quarter of domain
- $N_{\boldsymbol{\mu}} = 3$ parameters: $\boldsymbol{\mu} = [E; \nu; p]$
 - $E \in [50, 100]$ GPa, $\nu \in [0.20, 0.35]$, $p \in [6, 10]$ GPa
- 8 HF runs \rightarrow up to $m_{\mathbf{u}} = 8$ ROM basis functions (5 used – 99.90%)
- 30 parameter training instances for regression model

PCAP: Basis Functions



PCAP: Variance Unexplained for QoI Error Prediction

Regression Methods

OLS: Linear

OLS: Quadratic

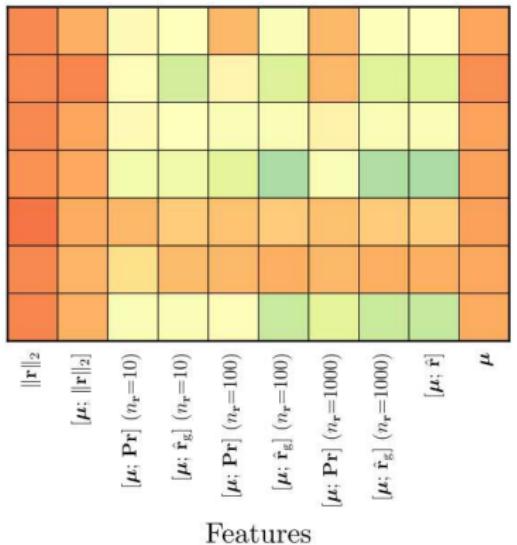
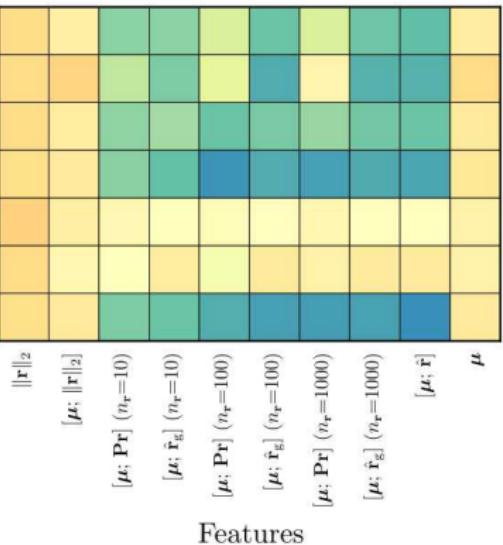
SVR: Linear

SVR: RBF

RF

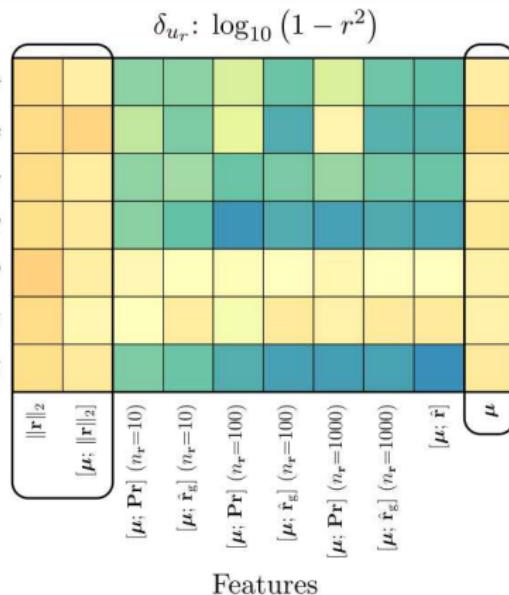
 k -NN

ANN

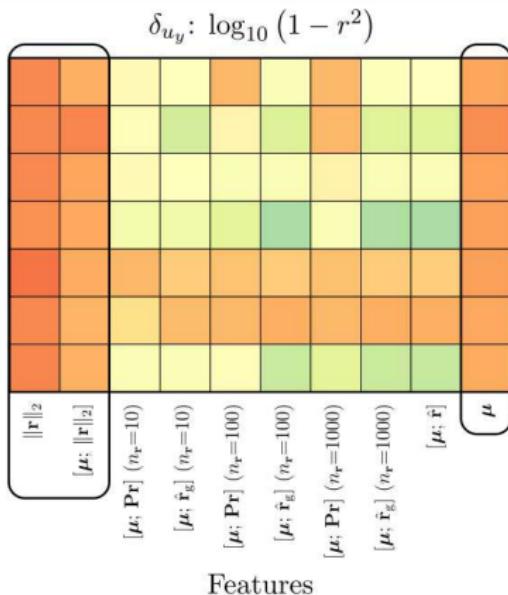


PCAP: Variance Unexplained for QoI Error Prediction

Regression Methods



Features

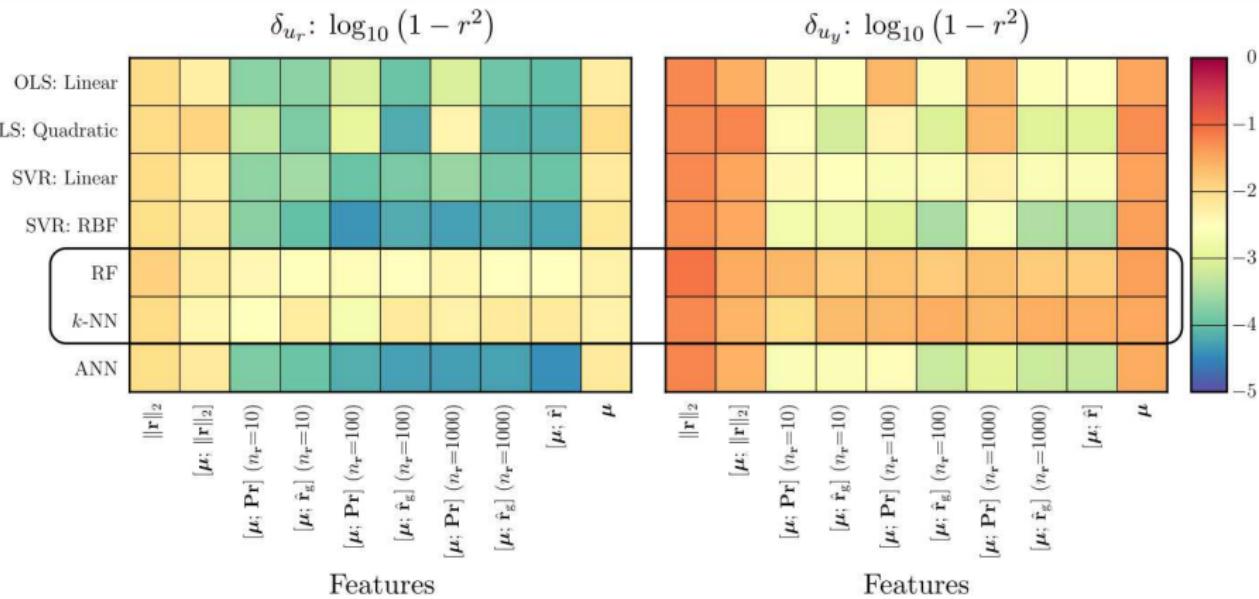


Features

- $\|\mathbf{r}\|$, $[\mu; \|\mathbf{r}\|]$, and μ yield **highest variance unexplained**

PCAP: Variance Unexplained for QoI Error Prediction

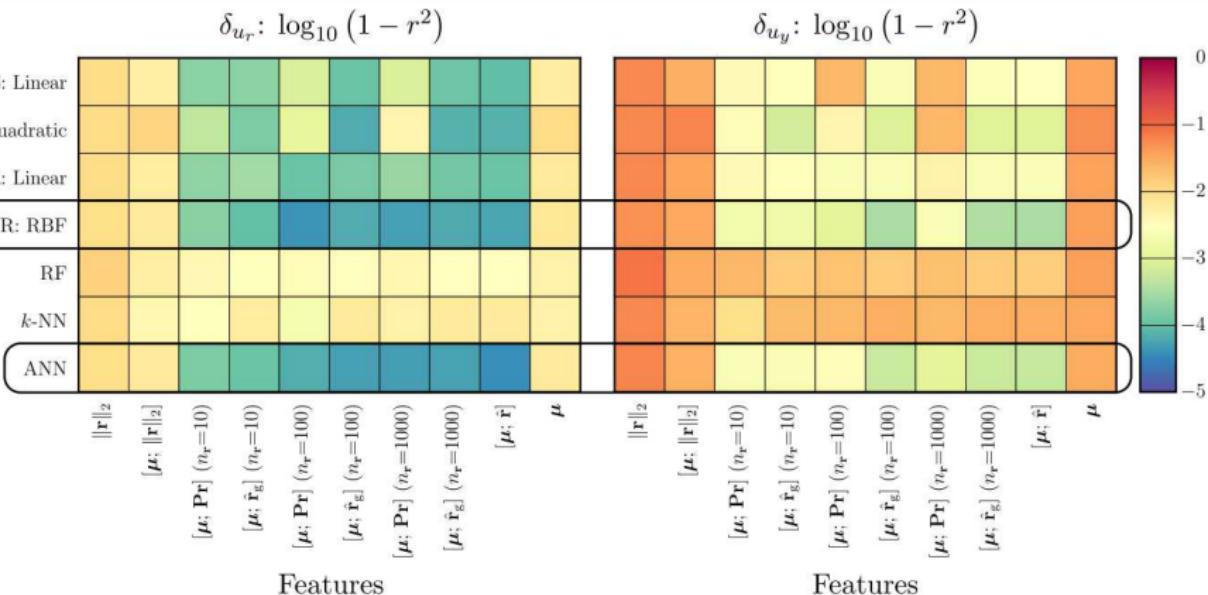
Regression Methods



- $\|r\|$, $[\mu; \|r\|]$, and μ yield **highest variance unexplained**
- RF and k -NN yield **highest variance unexplained**

PCAP: Variance Unexplained for QoI Error Prediction

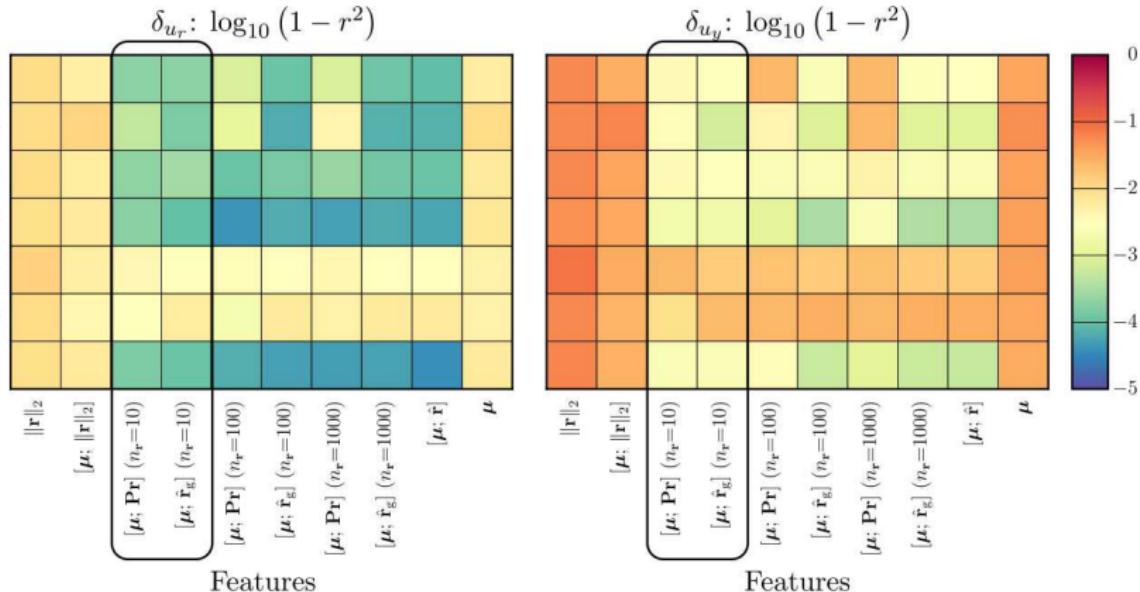
Regression Methods



- $\| \mathbf{r} \|$, $[\mu; \| \mathbf{r} \|]$, and μ yield **highest variance unexplained**
- RF and k -NN yield **highest variance unexplained**
- SVR: RBF and ANN yield **lowest variance unexplained**

PCAP: Variance Unexplained for QoI Error Prediction

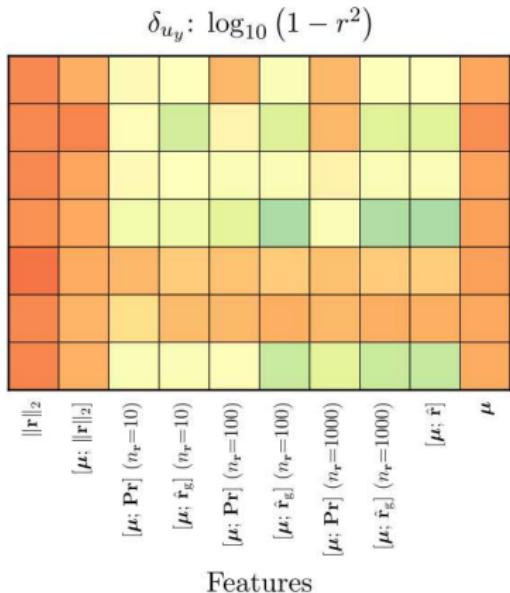
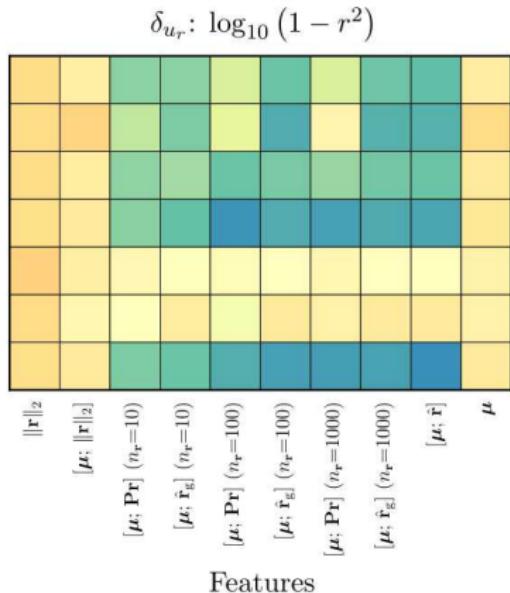
Regression Methods



- $\|\mathbf{r}\|$, $[\mu; \|\mathbf{r}\|]$, and μ yield **highest variance unexplained**
- RF and k -NN yield **highest variance unexplained**
- SVR: RBF and ANN yield **lowest variance unexplained**
- $[\mu; \hat{\mathbf{r}}_g]$ and $[\mu; \mathbf{Pr}]$ yield **low variance unexplained** with only 10 samples (compared to $N_u = 274, 954$)

PCAP: Variance Unexplained for QoI Error Prediction

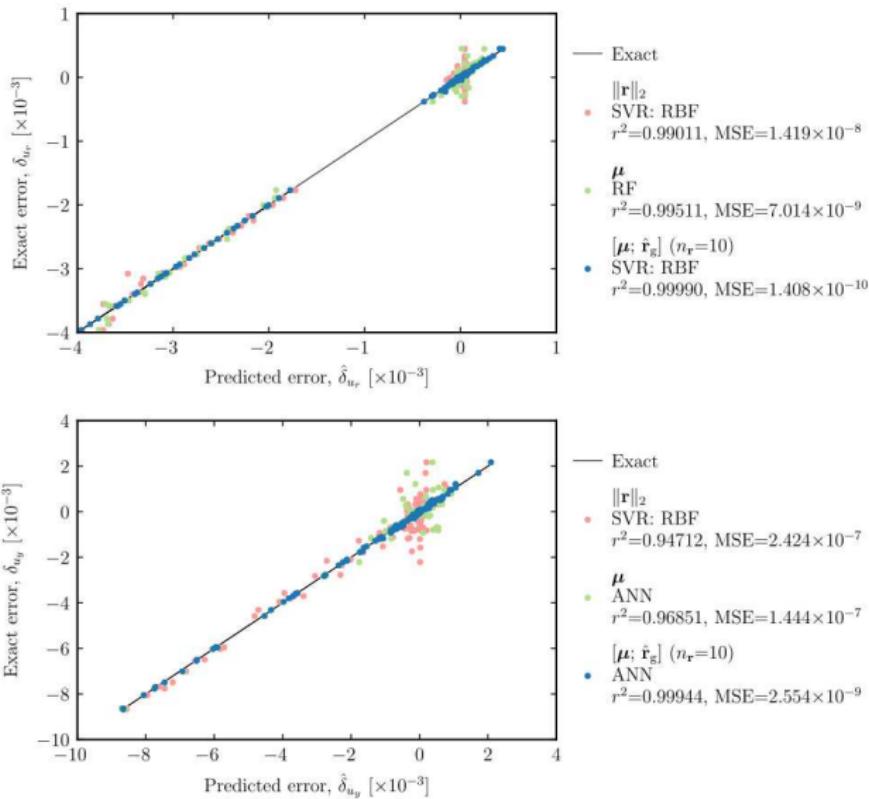
Regression Methods



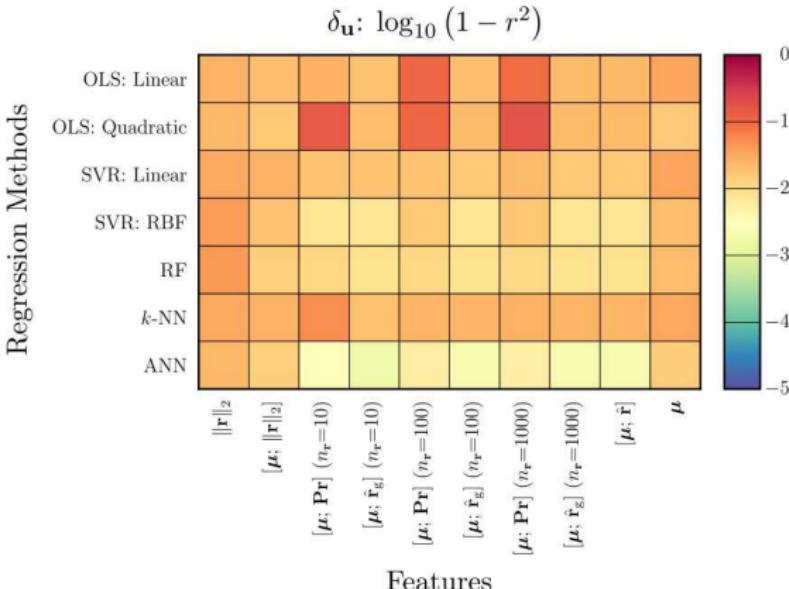
- $\|\mathbf{r}\|$, $[\mu; \|\mathbf{r}\|]$, and μ yield **highest variance unexplained**
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PCAP: QoI Error Predictions

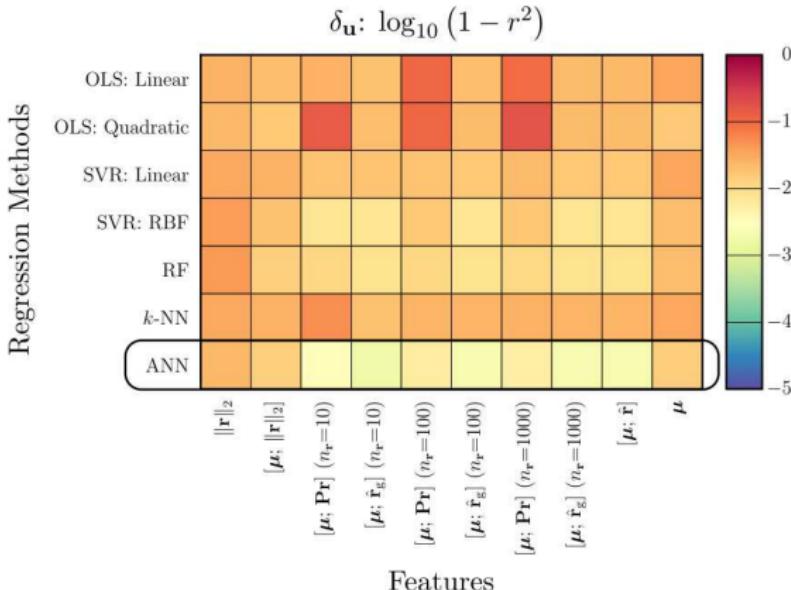
- Our method beats previous state-of-the-art methods with $r^2 > 0.9994$ in both cases



PCAP: Variance Unexplained for Normed State-Space Error Prediction

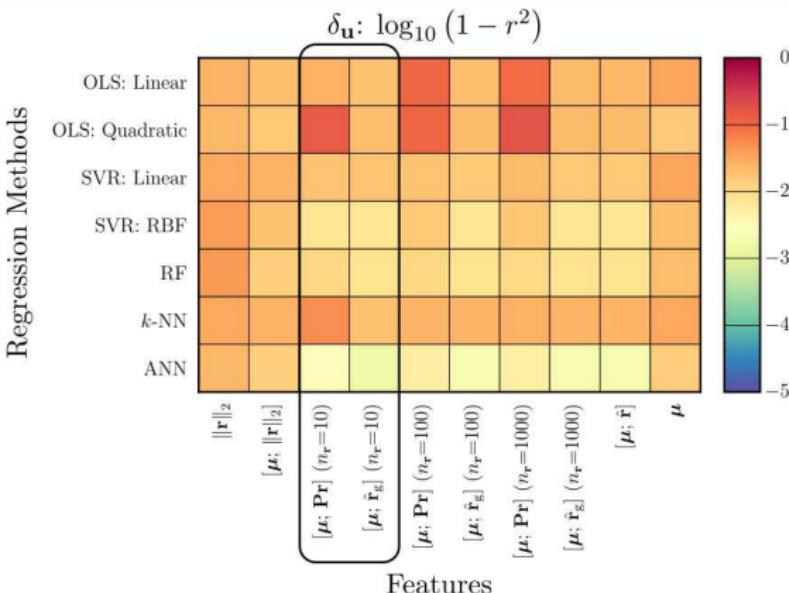


PCAP: Variance Unexplained for Normed State-Space Error Prediction



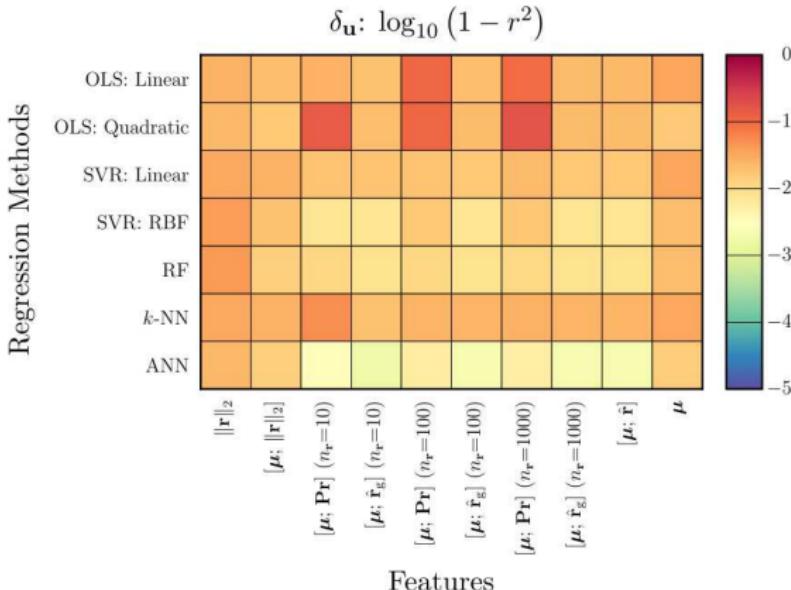
- ANN yields **lowest variance unexplained**

PCAP: Variance Unexplained for Normed State-Space Error Prediction



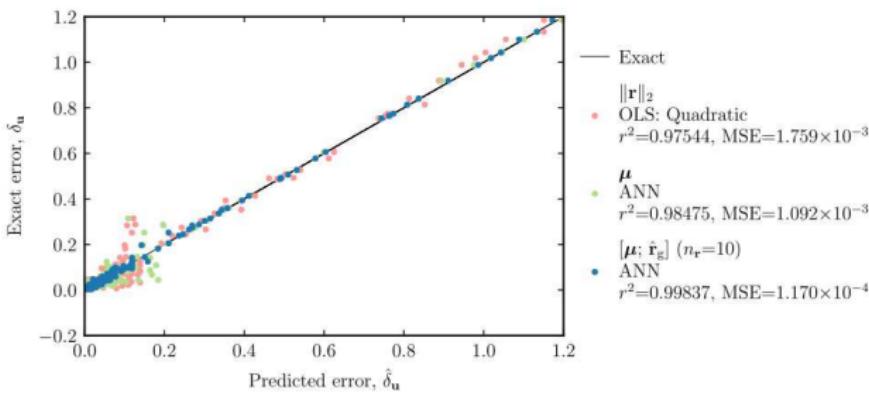
- ANN yields **lowest variance unexplained**
- $[\mu; \hat{\mathbf{r}}_g]$ and $[\mu; \mathbf{Pr}]$ yield **low variance unexplained** with only **10 samples** (compared to $N_u = 274,954$)

PCAP: Variance Unexplained for Normed State-Space Error Prediction



- ANN yields **lowest variance unexplained**
- $[\mu; \hat{\mathbf{r}}_g]$ and $[\mu; \mathbf{Pr}]$ yield **low variance unexplained** with only **10 samples** (compared to $N_{\mathbf{u}} = 274,954$)

PCAP: Normed State-Space Error Predictions

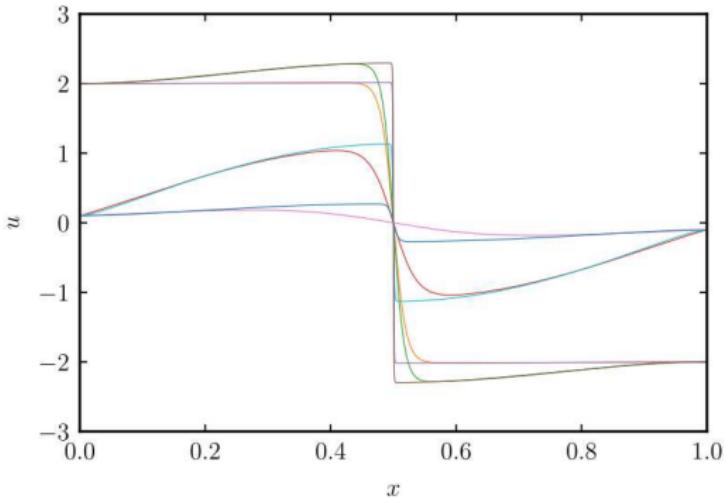


- Our method beats previous state-of-the-art methods with $r^2 > 0.998$

Burgers' Equation: Inexact Solutions and Coarse Solution Prolongation

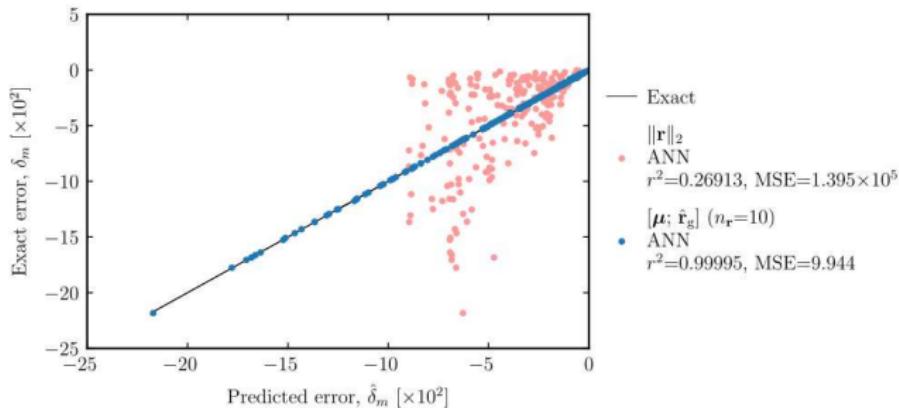
$$uu_x - \frac{1}{R}u_{xx} = \alpha \sin 2\pi x$$

$$u(0) = u_a, \quad u(1) = -u_a$$



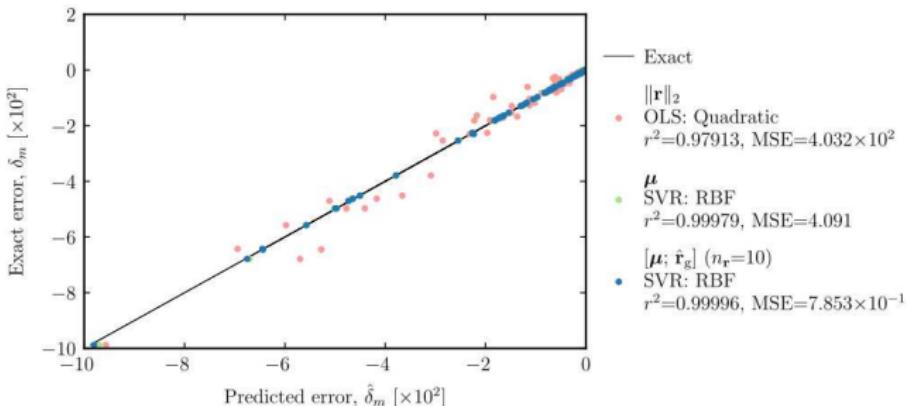
- $N_u = 1999$
- $N_\mu = 3$ parameters: $\mu = [\alpha; u_a; R]$
 - $\alpha \in [0.1, 2.0]$, $u_a \in [0.1, 2.0]$, $R \in [50, 1000]$
- Quantity of interest s is the slope m at $x = \frac{1}{2}$
- $\tilde{K} = 1$ and $\tilde{K} = 2$ or $N_{u_{LF}} = 499$ and $N_{u_{LF}} = 999$

Burgers' Equation, Inexact Solutions: QoI Error Predictions



- Our method beats previous state-of-the-art method with $r^2 > 0.9999$

Burgers' Equation, Coarse Mesh Prolongation: QoI Error Predictions



- Our method beats previous state-of-the-art methods with $r^2 > 0.9999$

Outline

- Introduction
- Parameterized Systems of Nonlinear Equations
- Proposed Approach
- Numerical Experiments
- Summary
 - Feature Choices
 - Feature Reduction

Feature Choices

- Norm of the residual, $\|\mathbf{r}\|$
 - Low-quality single feature
 - Expensive to compute and performs poorly
- Dual-weighted residual, d
 - High-quality single feature
 - Performs well for small amounts of training data
 - Very expensive to compute
- Parameters $\boldsymbol{\mu}$
 - Only perform well with SVR: RBF or ANN
 - Do not perform well with OLS: Linear
- Parameters and gappy principal components of residual, $[\boldsymbol{\mu}; \hat{\mathbf{r}}_g]$
 - Perform the best with $r^2 > 0.996$ for each experiment
 - Only require about 13 features

Feature Reduction

- Gappy PCA more effective than directly sampling the residual
- Little benefit to using $n_r \geq 100$ samples; more samples are more expensive and do not perform much better
- Often, only $n_r = 10$ samples are necessary to get accurate prediction

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Questions?

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